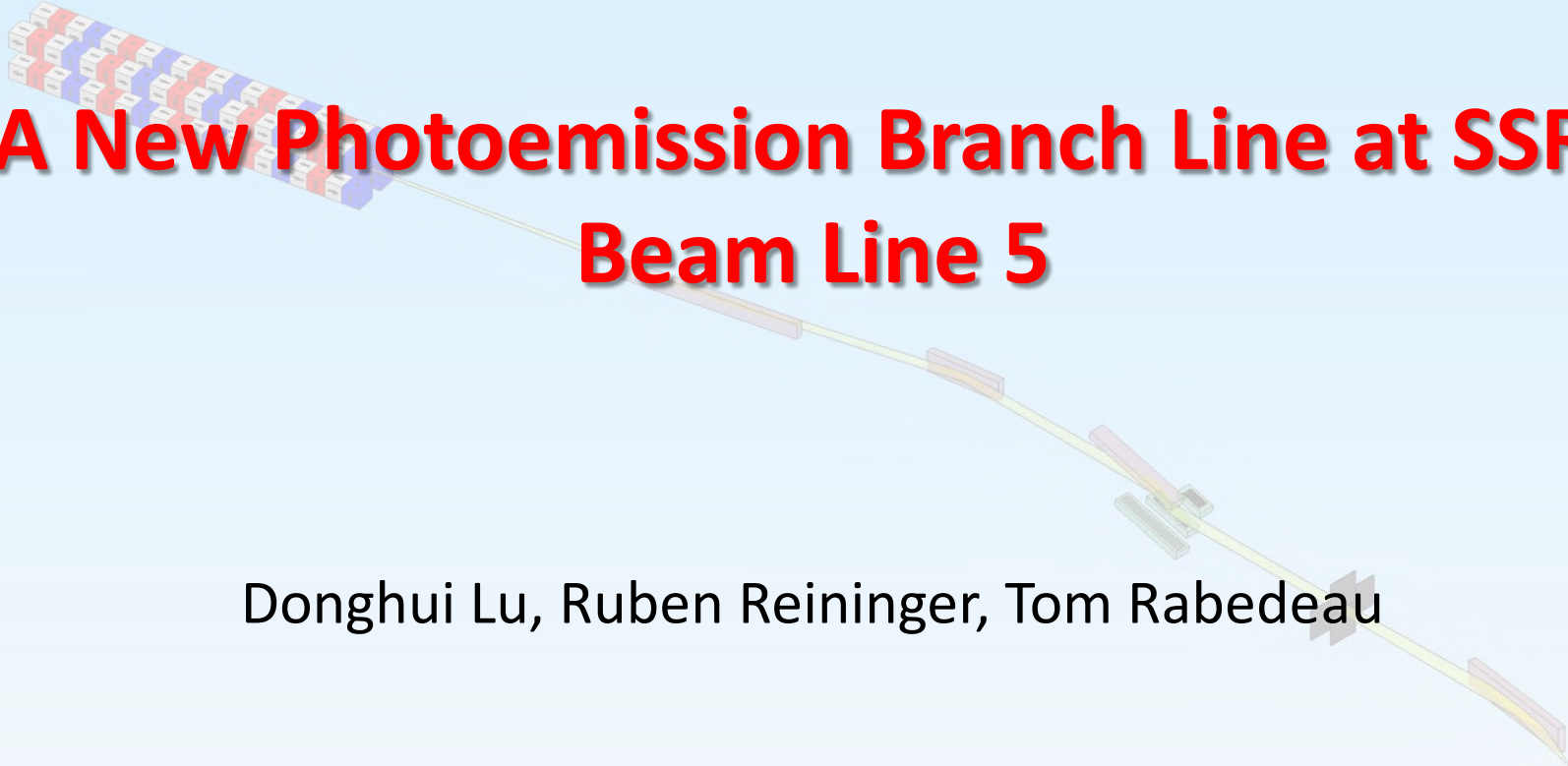


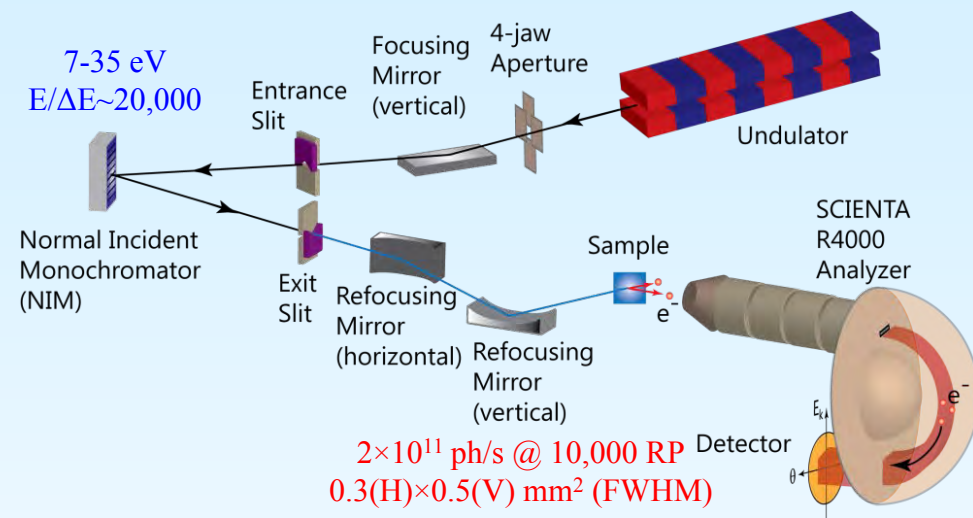


A New Photoemission Branch Line at SSRL Beam Line 5

Donghui Lu, Ruben Reininger, Tom Rabedeau



Present Status of ARPES System at SSRL



• ARPES End Station on NIM Branchline

☺ Advantages:

high resolution; low energy; high order suppression; good beam stability

☹ Disadvantages:

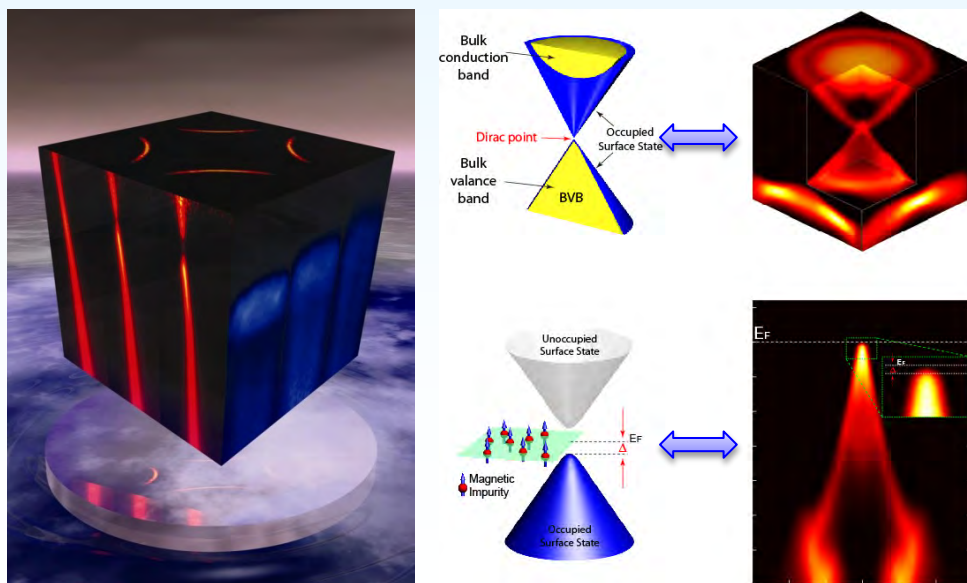
limited photon energy range; no polarization control; large beam size

• Dedicated for High Resolution ARPES

- High temperature superconductors
- Complex oxides
- Novel low dimensional systems
- Materials in delicate balance
- Topological insulators
-

• Planned Upgrade

- New refocusing mirror
- New undulator PGM branchline



New Undulator Branchline

- **Significantly Improved Performance**

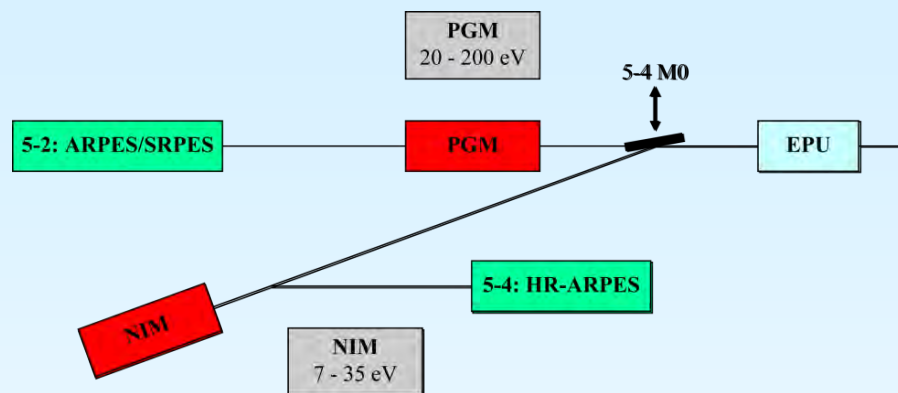
- Wider photon energy
- Variable polarizations
- Smaller beam size

- **Complementary to NIM Branchline**

- NIM – ultrahigh resolution in low energy
- PGM – higher energy, higher flux, flexibility
 - spin-resolved ARPES
 - PLD-MBE thin film growth

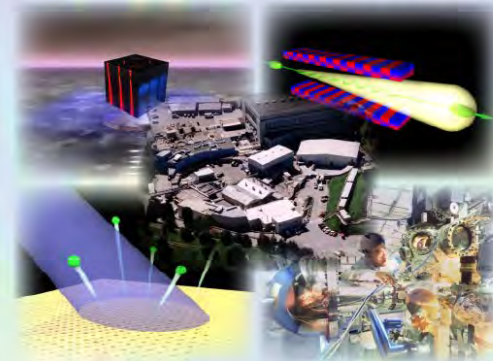
- **Project Milestones**

- First proposal submitted in Feb 2005
- Resubmitted in 2006 & 2009
- Funding received in Sept 2009
- EPU procured in Sept 2010
- CDR for optical design completed in Dec 2010
- Monochromator and gratings procured in Sept 2011
- Installation of new EPU during 2012 shutdown
- Installation of PGM branchline after 2012 shutdown
- Commission starts early 2013



Modern Angle-Resolved Photoemission Spectroscopy Beamline for the Study of Complex Phenomena in Solids

D. H. Lu, Z.-X. Shen, Z. Hussain, R. G. Moore, P. Pianetta,
A. Fujimori, E. W. Plummer, G. A. Sawatzky, D. S. Dessau,
M. Z. Hasan, F. Baumberger, V. Brouet, A. Damascelli, C. Kim



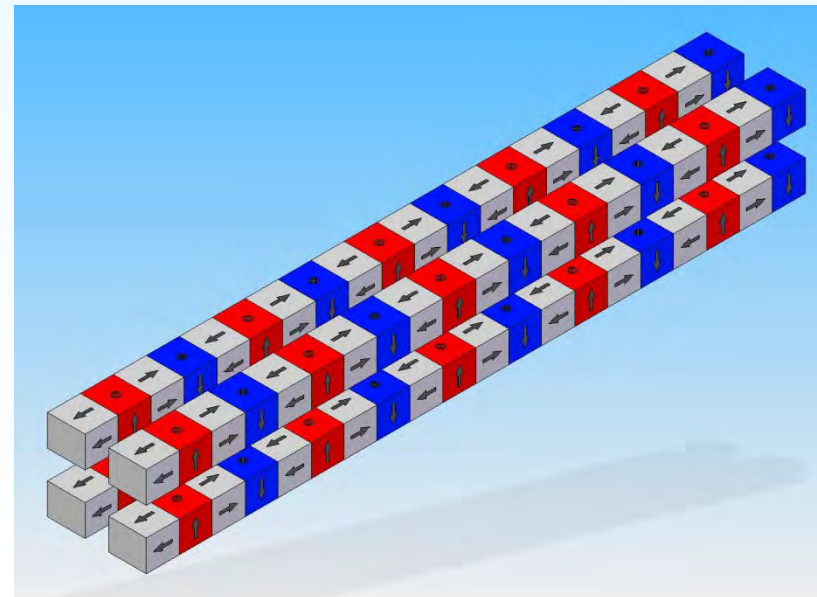
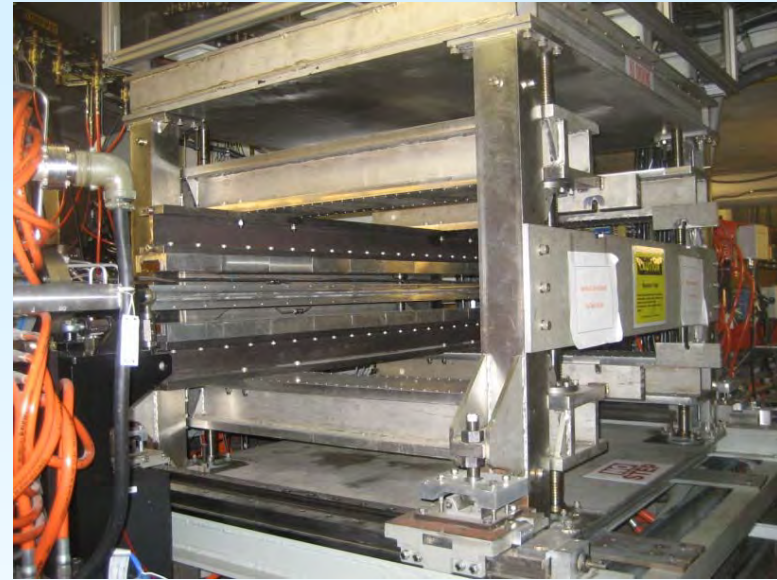
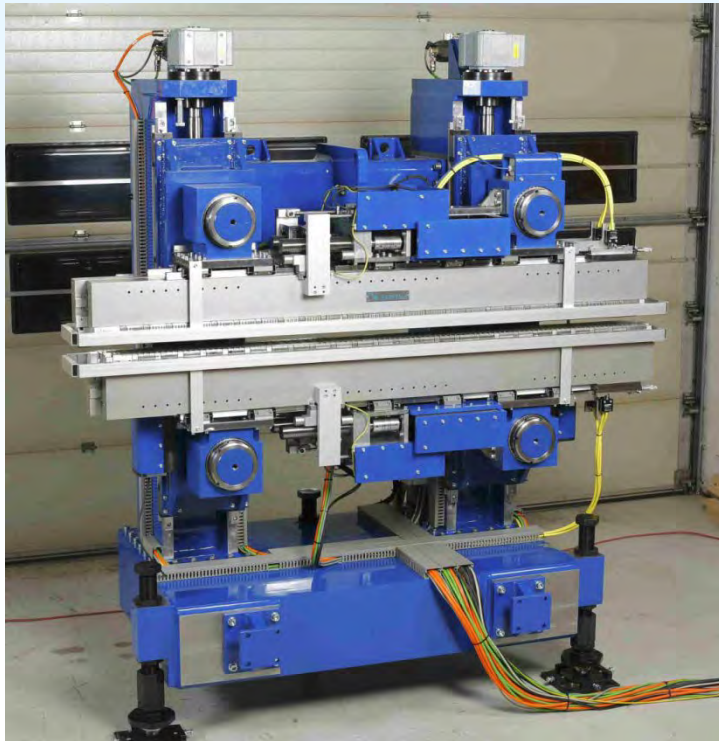
Submitted by SSRL and SIMES, SLAC National Accelerator Laboratory
Single-Investigator and Small-Group Research Proposal - Midscale Instrumentation

Design Goal

- Energy range between 20 and 200 eV
- $RP > 25,000$ in the high resolution mode
- $RP > 10,000$ in the high flux mode
- At $RP\ 10,000$ flux $> 10^{12}$ photons/s
- Spot size $< 100 \times 50\ \mu\text{m}^2$ (hor. $\times$ ver.)
- Higher orders should be minimized
- Linear horizontal, vertical, and circular polarization
- Available space is 31 m from the ID center

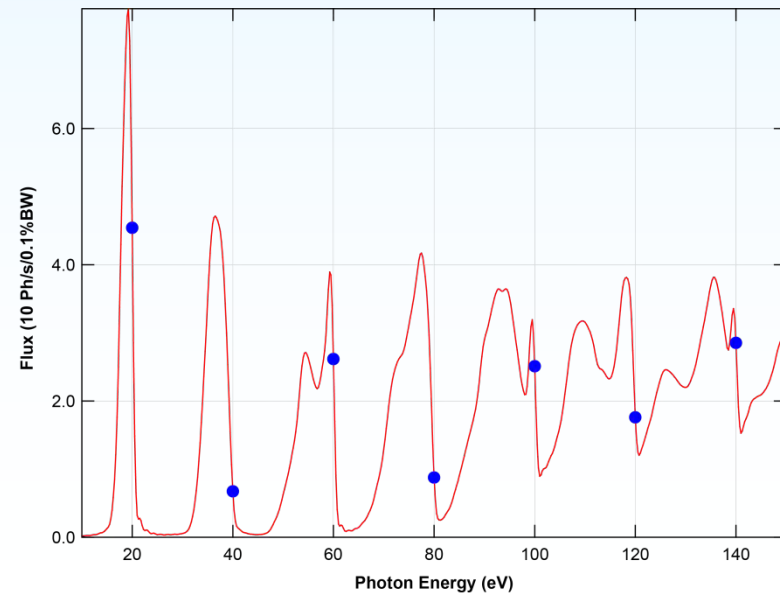
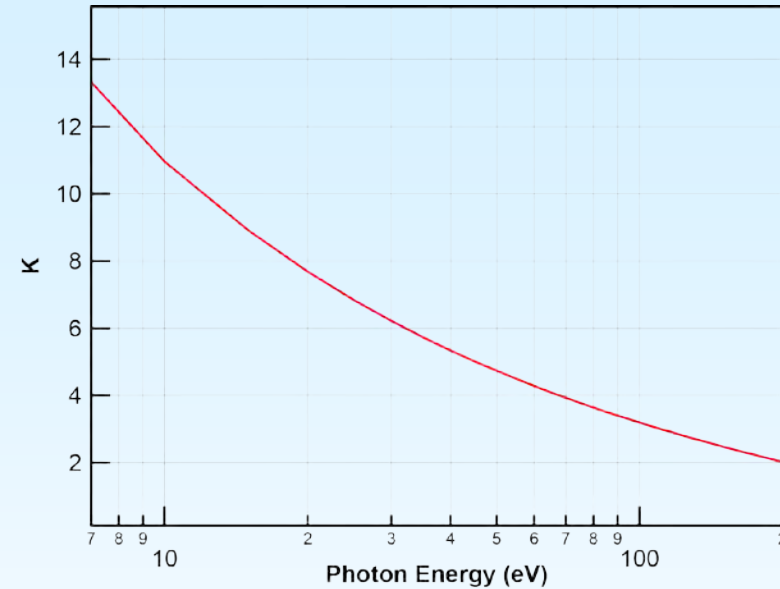
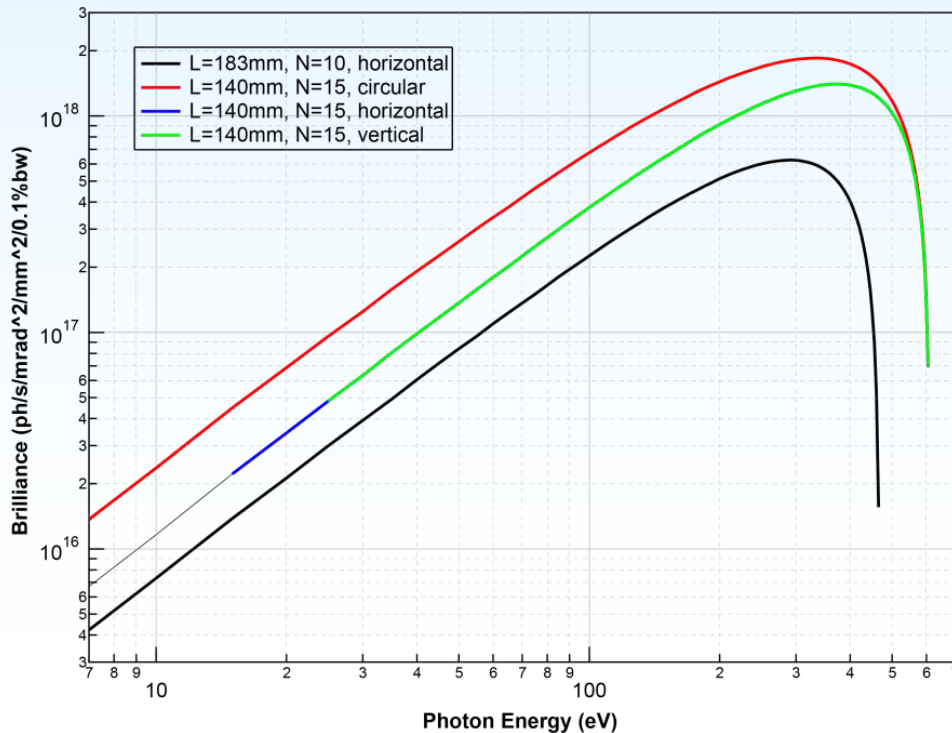
Critical Decision I: Undulator

- **Existing Undulator**
 - Planar, 10-pd x 183mm, 18.5mm gap $\Rightarrow$ 7 eV
- **Single vs. Twin Device**
- **New Undulator**
 - APPLE II, 15-pd x 140mm, 13mm gap $\Rightarrow$ 7 eV
 - High K $\Rightarrow$ strong high orders, high heat load



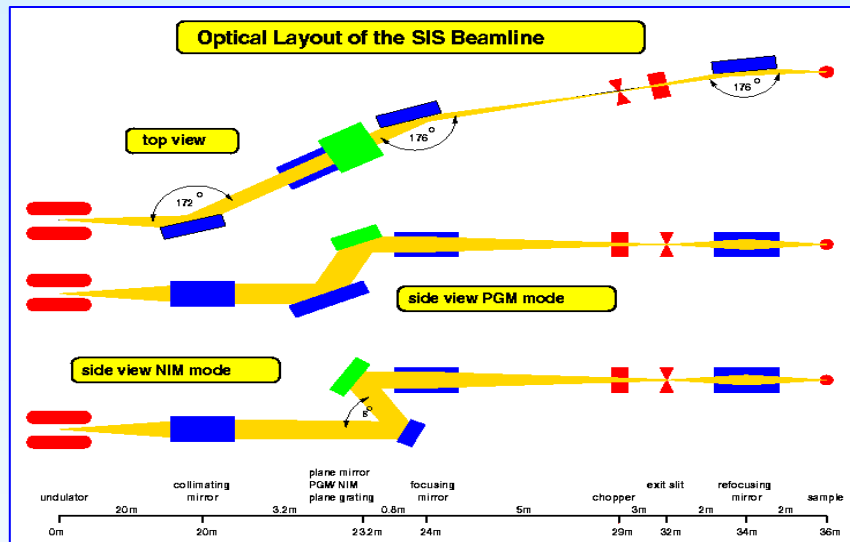
Critical Decision I: Undulator

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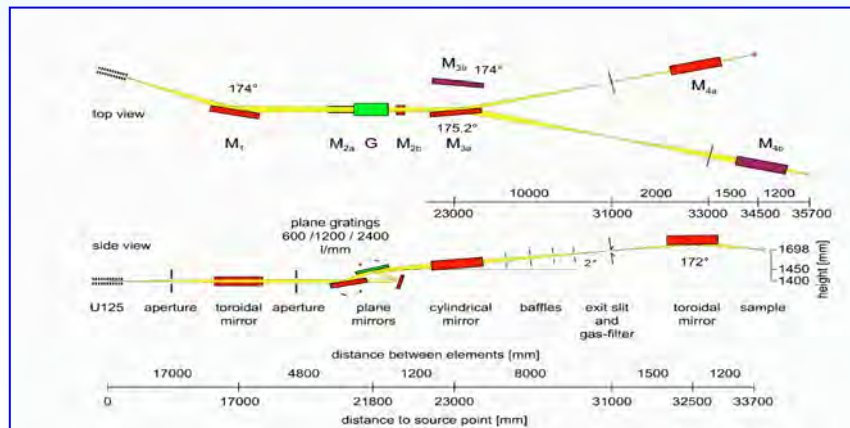


Critical Decision II: Monochromator

CPGM

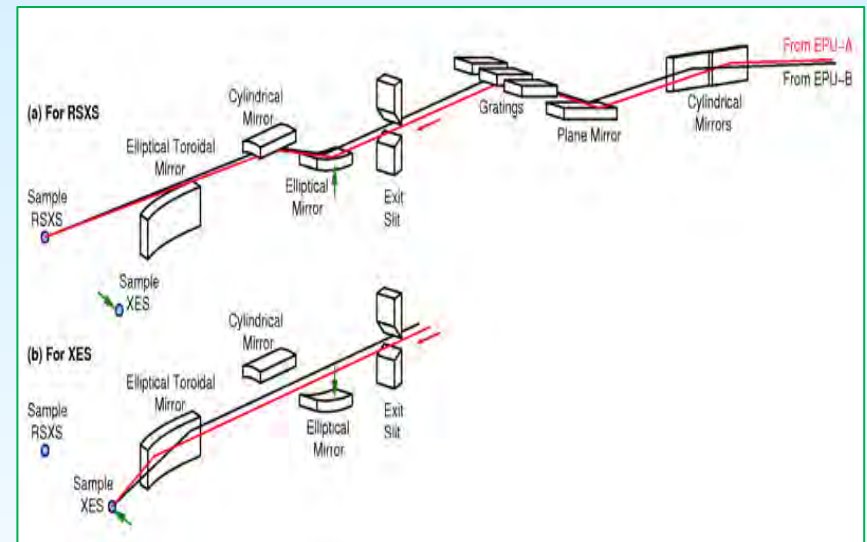


SLS - SIS

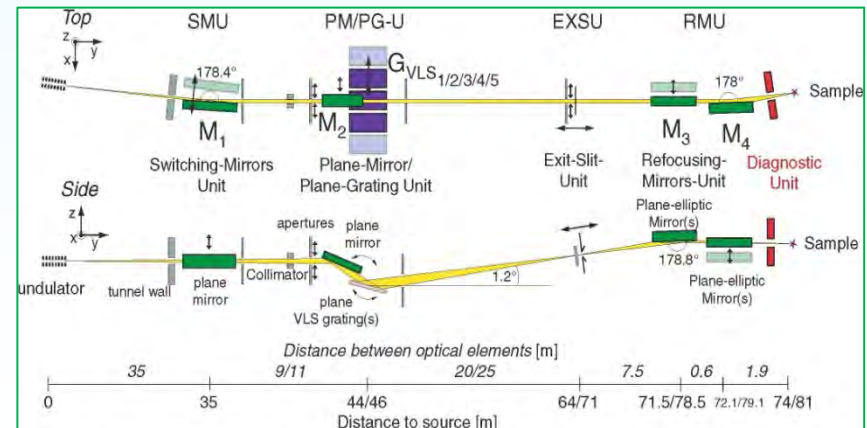


BESSY - UE112

FVLSPGM



CLS - REIXS



PETRA III - P04

Resolution Terms

Grating Equation:

$$n k \lambda = \sin \alpha + \sin \beta$$

Resolution Entrance:

$$n k \delta \lambda_{en} = \cos \alpha \delta \alpha = \cos \alpha s_{en} / r_1$$

Resolution Exit:

$$n k \delta \lambda_{ex} = \cos \beta \delta \beta = \cos \beta s_{ex} / r_2$$

Slope error ϵ

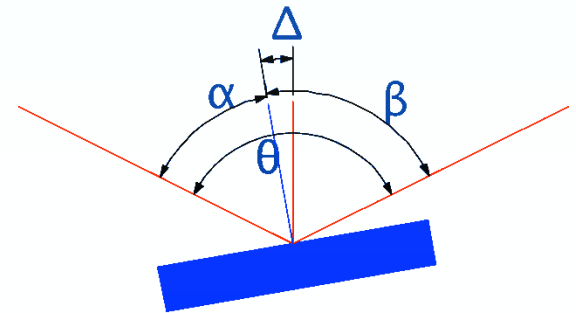
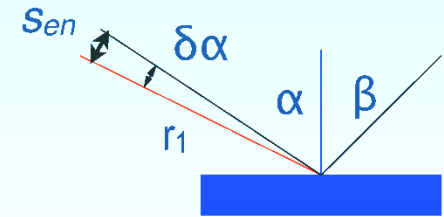
$$\sin \alpha + \sin \beta = 2 \cos \theta \sin \Delta$$

$$\theta = \frac{\alpha + \beta}{2}; \quad \Delta = \frac{\alpha - \beta}{2}$$

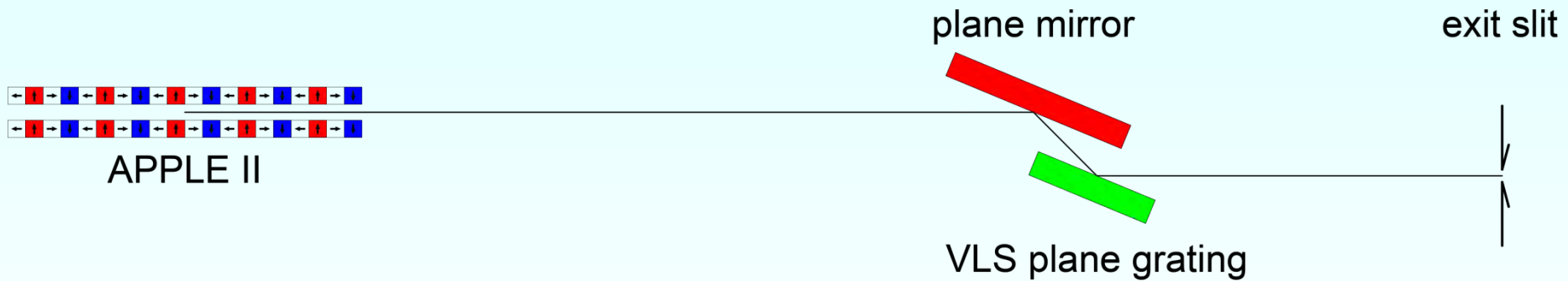
$$n k \delta \lambda_{err} = \delta(2 \cos \theta \sin(\Delta + \epsilon)) \approx 2 \epsilon \cos \theta \cos \Delta$$

$$n k \delta \lambda_{err} \approx \epsilon (\cos \alpha + \cos \beta)$$

Aberrations: Coma, spherical, astigmatic coma...



FVLSPGM



$$k(w) = k_0(1 + 2b_2 w + 3b_3 w^2 + \dots)$$

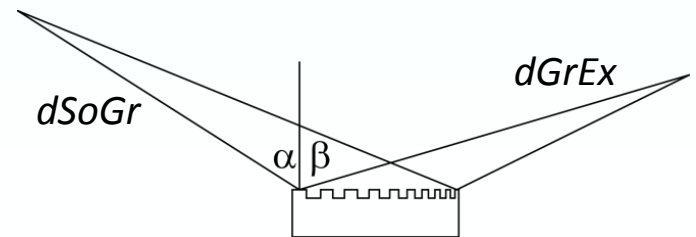
$$f_{20} = \frac{\cos^2 \alpha}{dSoGr} + \frac{\cos^2 \beta}{dGrEx} - 2b_2 n k_0 \lambda$$

$$f_{30} = \sin \alpha \frac{\cos^2 \alpha}{dSoGr^2} + \sin \beta \frac{\cos^2 \beta}{dGrEx^2} - 2b_3 n k_0 \lambda,$$

$$\text{PM: } \gamma = 0.5(\alpha - \beta)$$

$$n k \lambda = \sin \alpha + \sin \beta \text{ \& } f_{20} = 0$$

$$c = \cos \beta / \cos \alpha$$



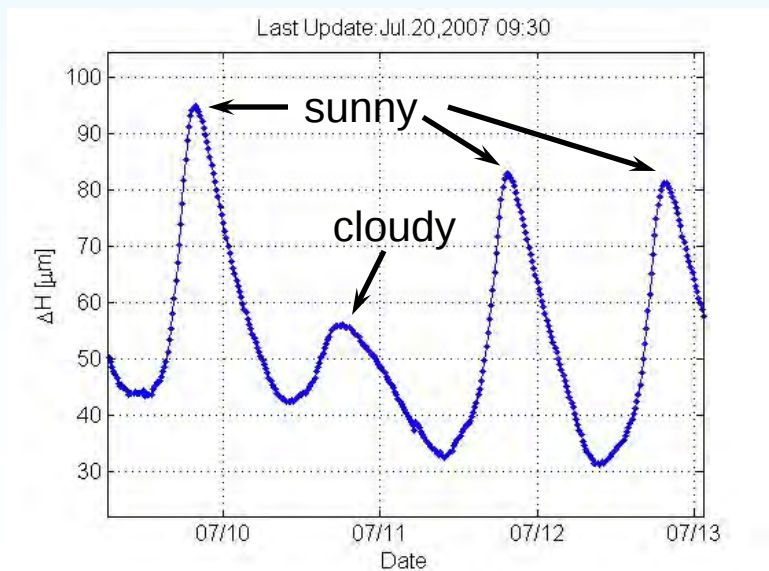
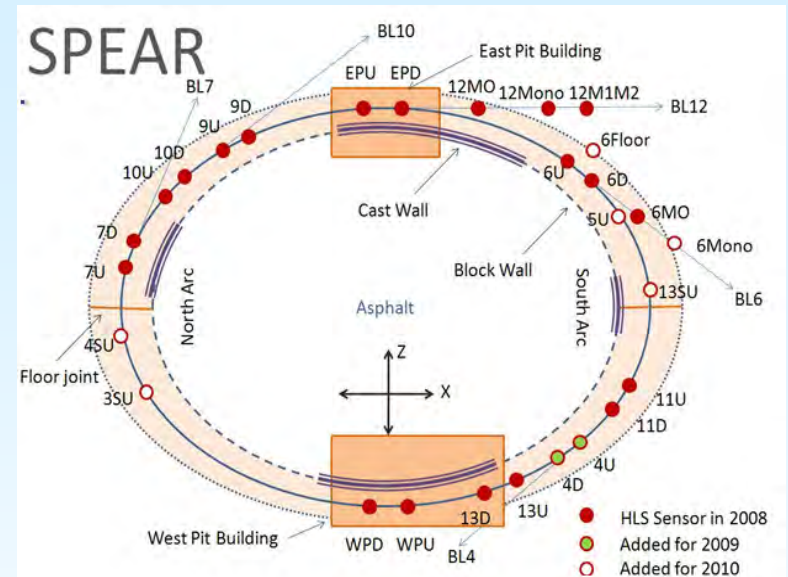
T. Harada, *et. al.*, Proc. SPIE, 503:114, (1984)

R. Reininger *et. al.*, Rev. Sci. Instrum., 79, 033108 (2008)

Critical Decision II: Monochromator

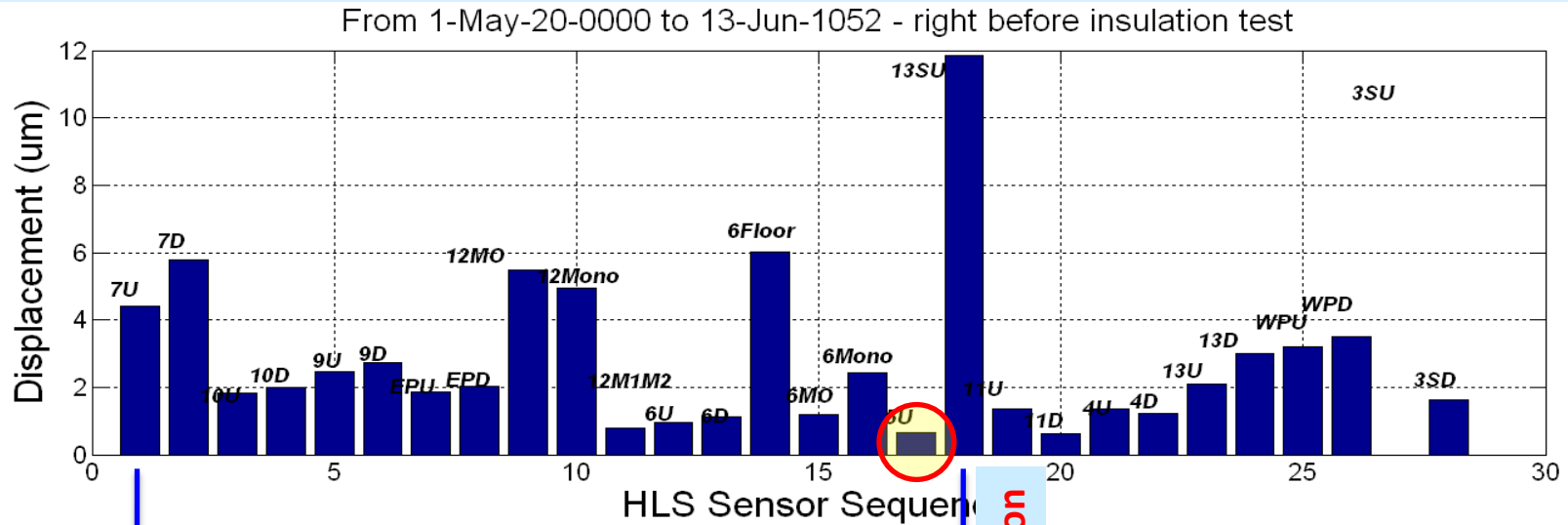
	FVLSPGM	CPGM
Mechanics	SX-700 type	SX-700 type
Fixed exit slit	Yes	Yes
c value	Fixed Some order suppression	Variable Slightly better order suppression Resolution vs Flux
Optical components	Can use only planes in between source and slit	+toroid and cylinder More reflections Cannot achieve 10^5 at 1 keV
Large horizontal Demagnification.	With single mirror	Two demagnifying mirrors.
Correct Heat Induced deformations M2	Yes, variable focal length.	No

Critical Decision III: Entrance Slit

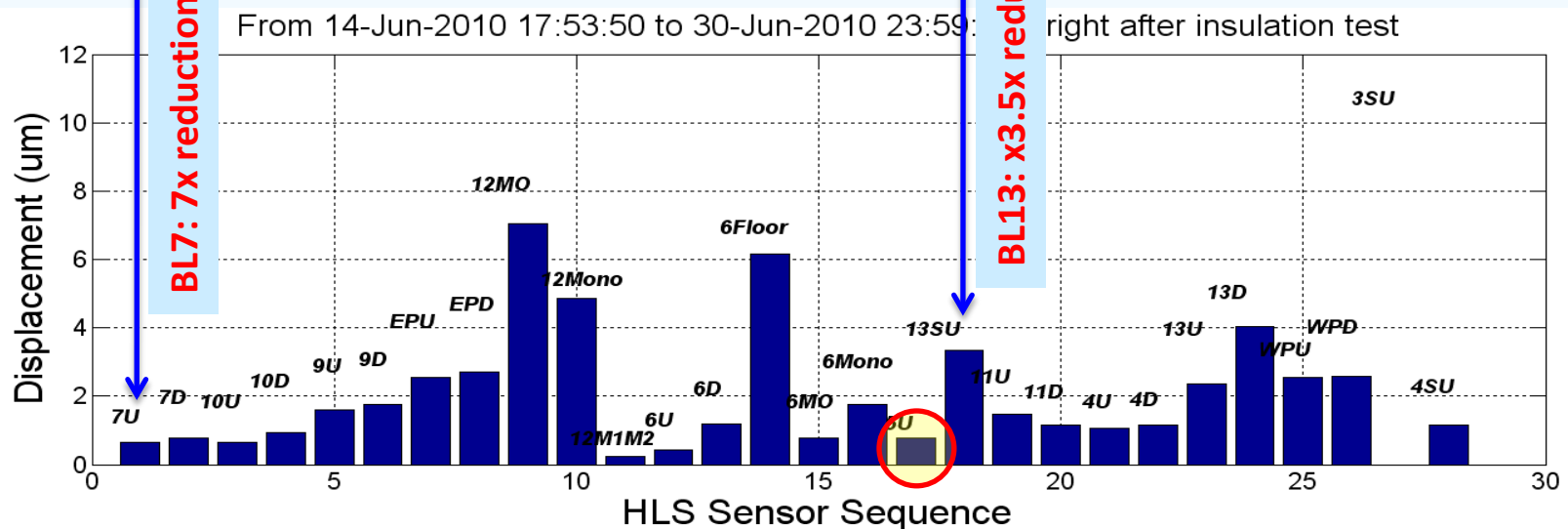


Critical Decision III: Entrance Slit

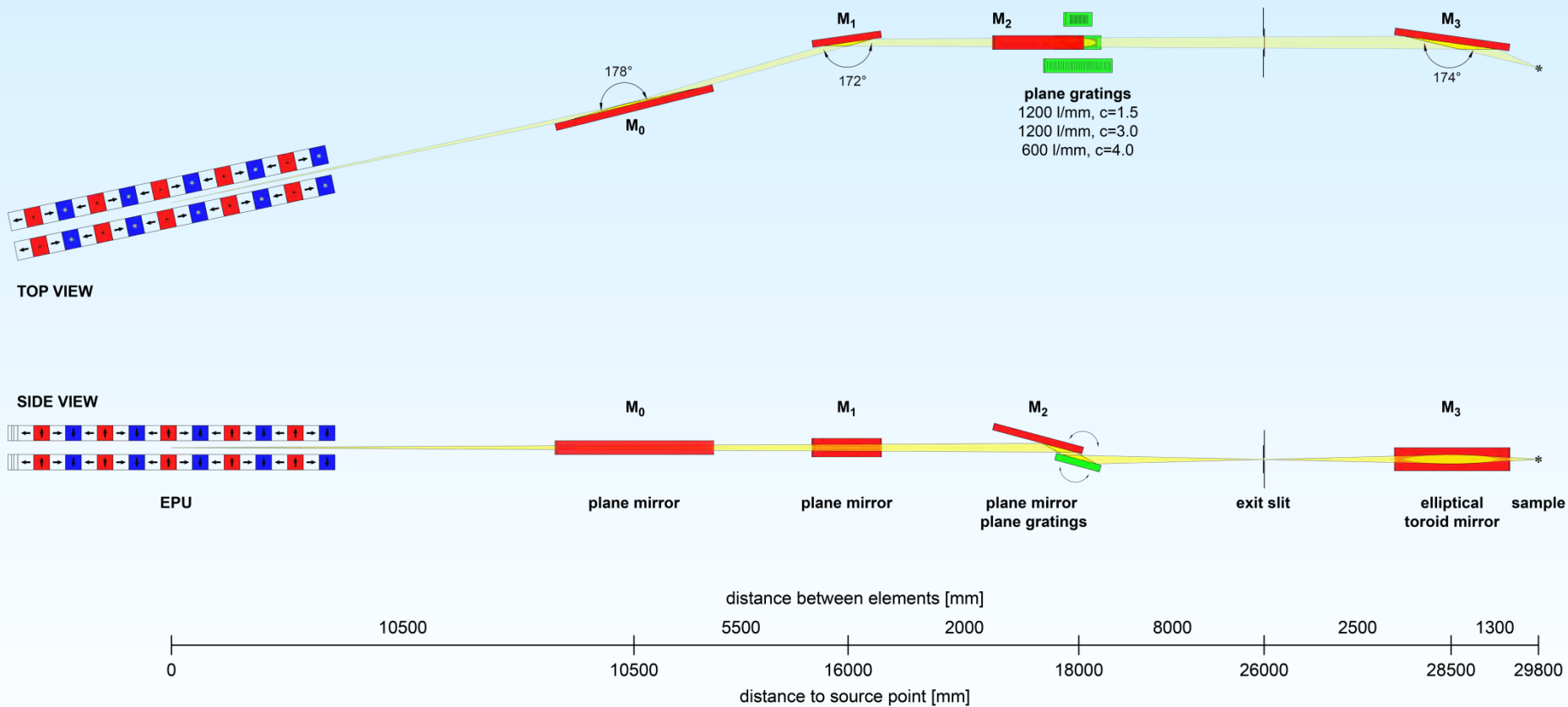
Before Insulation



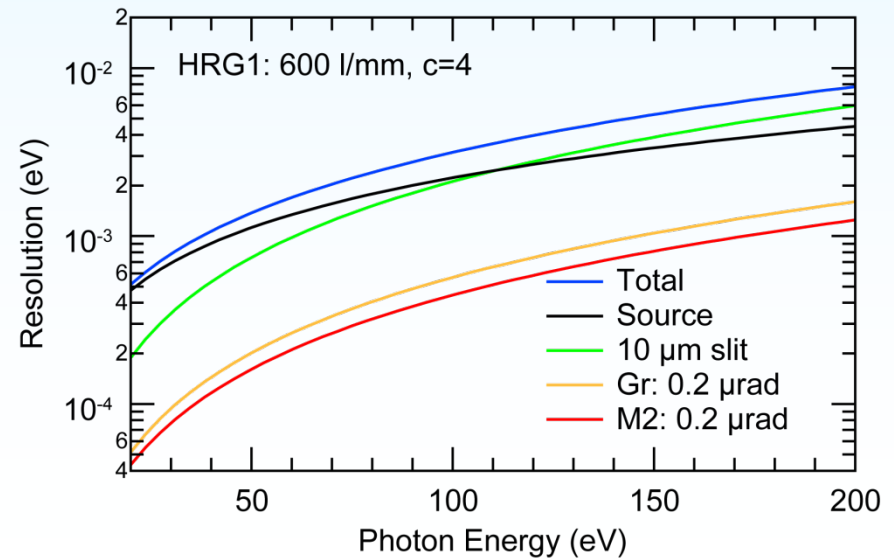
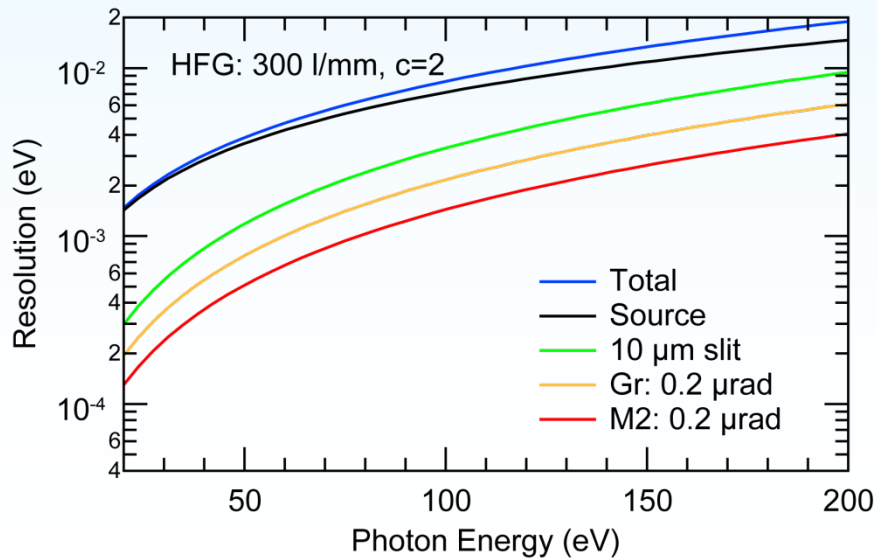
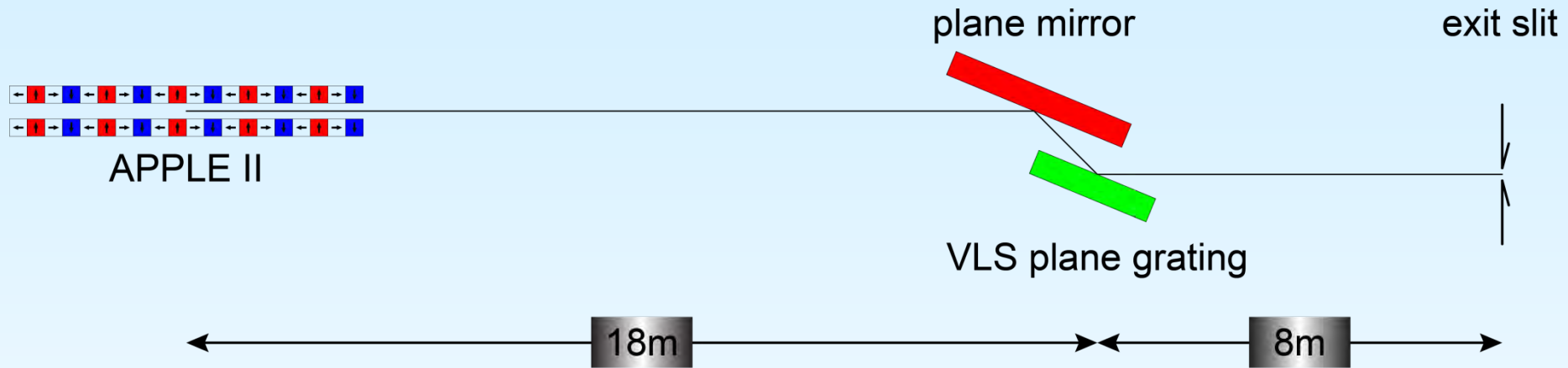
After Insulation



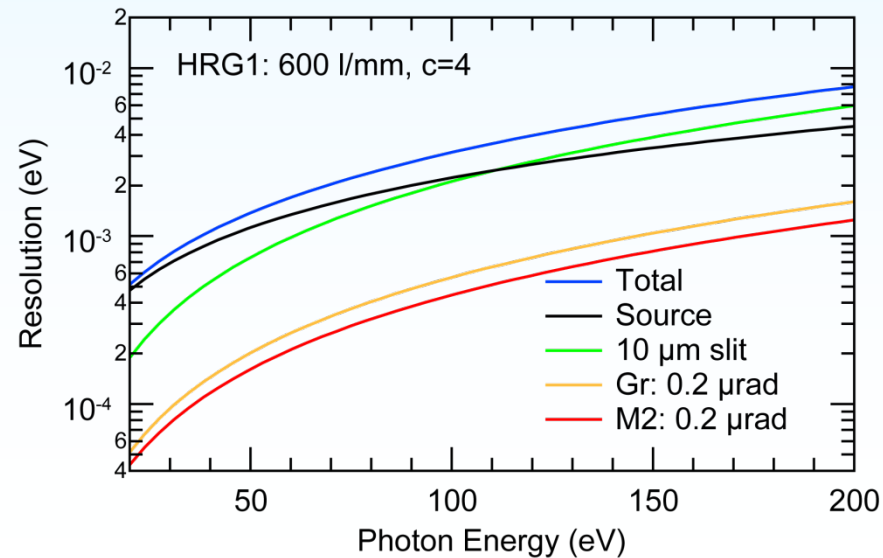
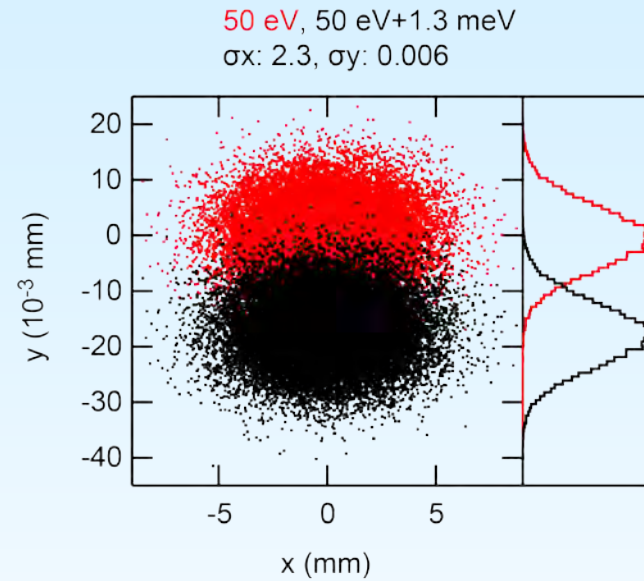
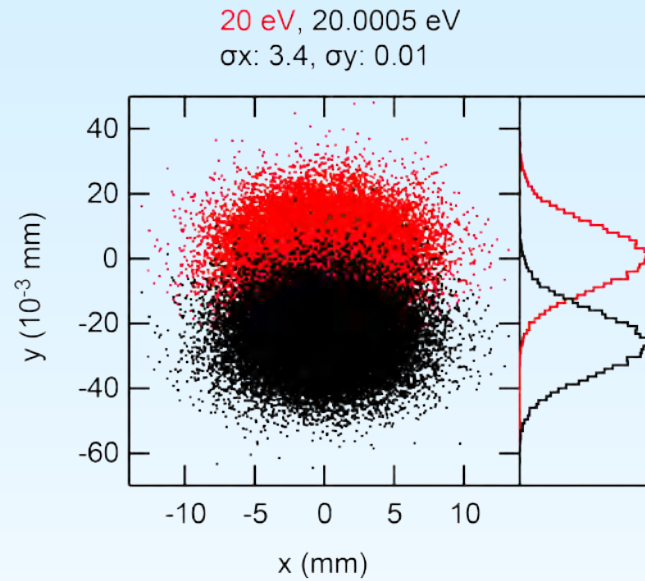
Optical Layout



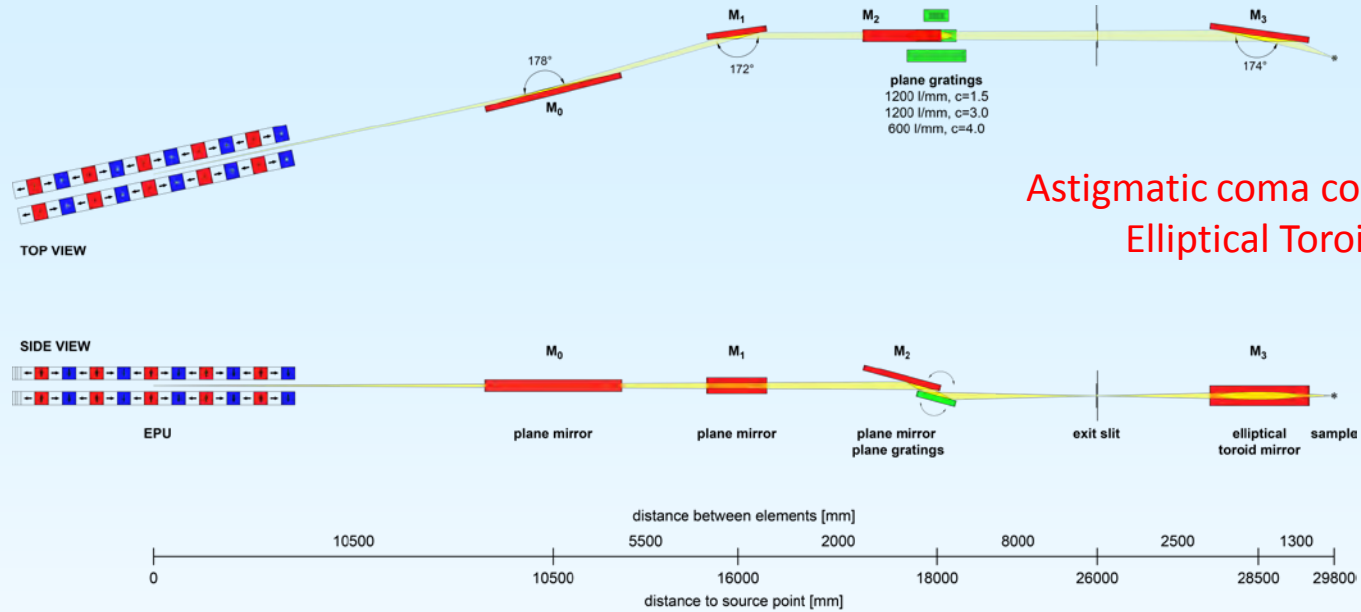
Resolution



Ray Tracing: HRG1

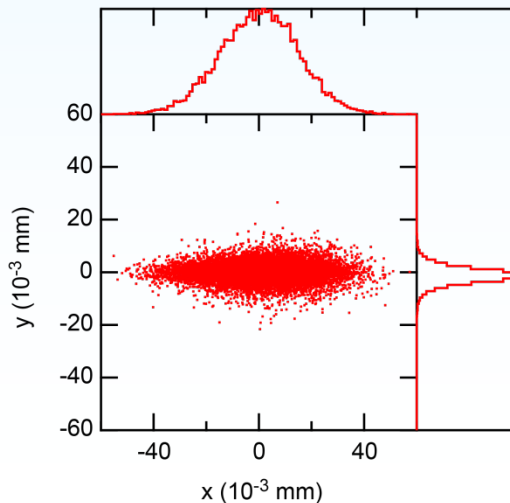
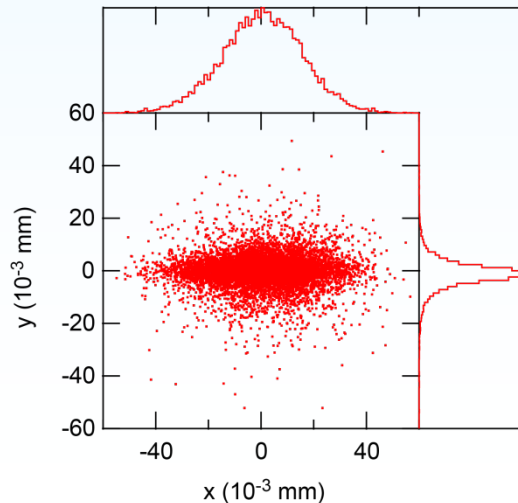


Ray Tracing: Refocusing



Sample, 20 eV HFG, 10 μ m slit
 σ_x : 0.015, σ_y : 0.006

Sample, 50 eV HRG1, 10 μ m slit
 σ_x : 0.015, σ_y : 0.0033

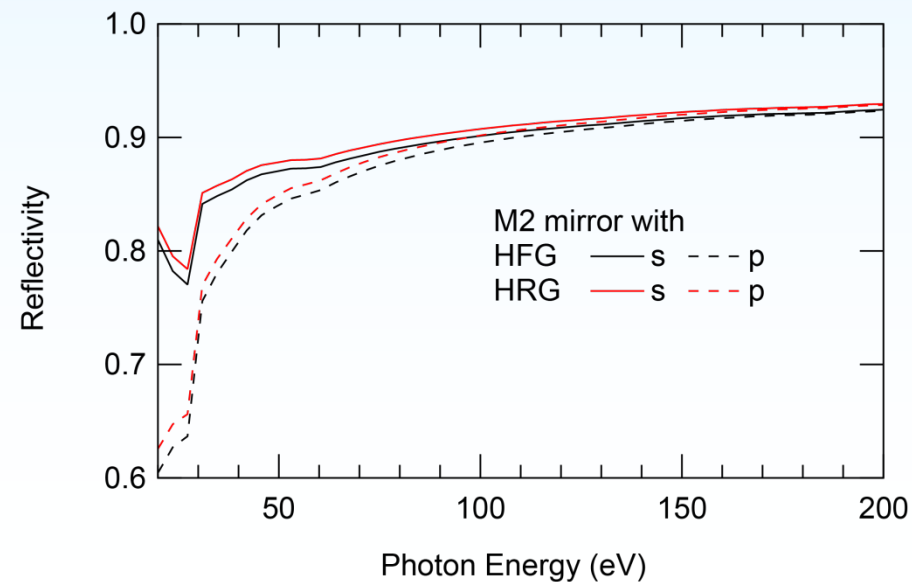
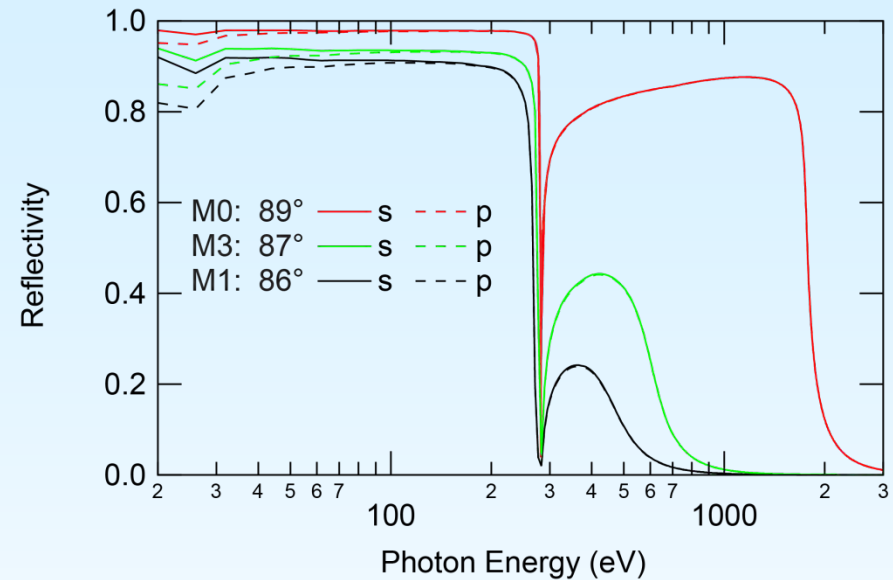
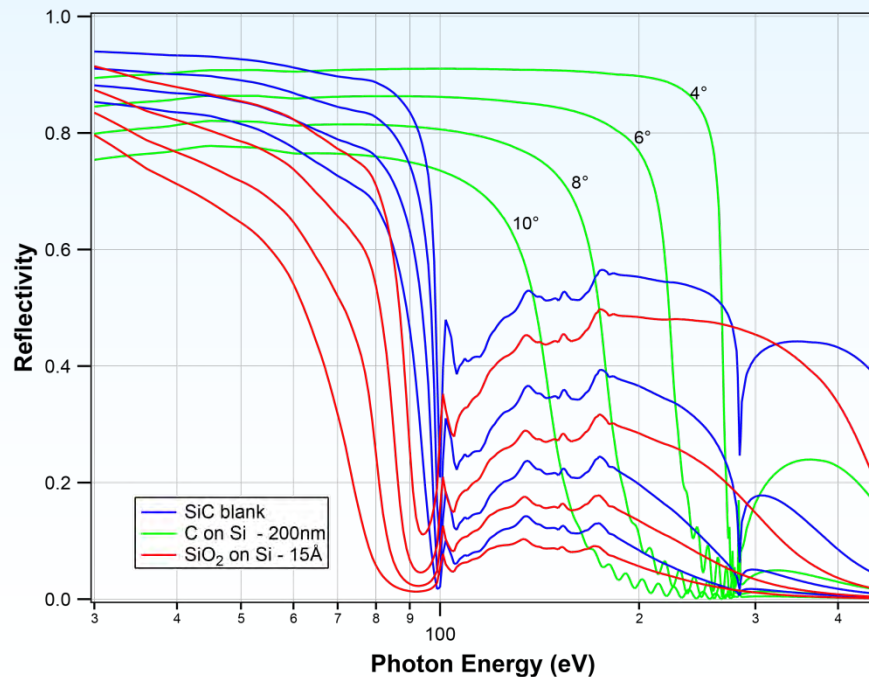


$$rm_2 = rs_2 = \frac{rm_1 \times rs_1}{2rm_1 - rs_1}$$

28.5:1.3 meridional horizontal
2.5:1.3 sagittal vertical

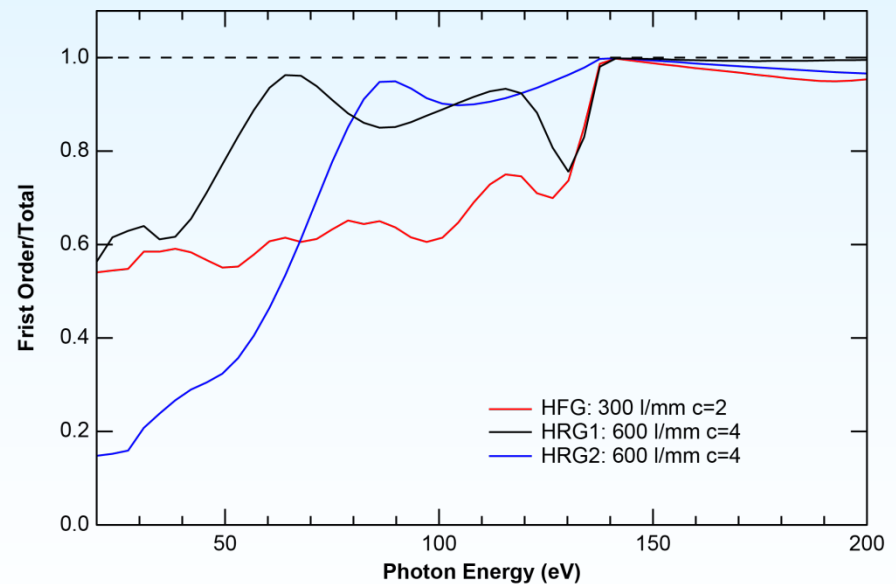
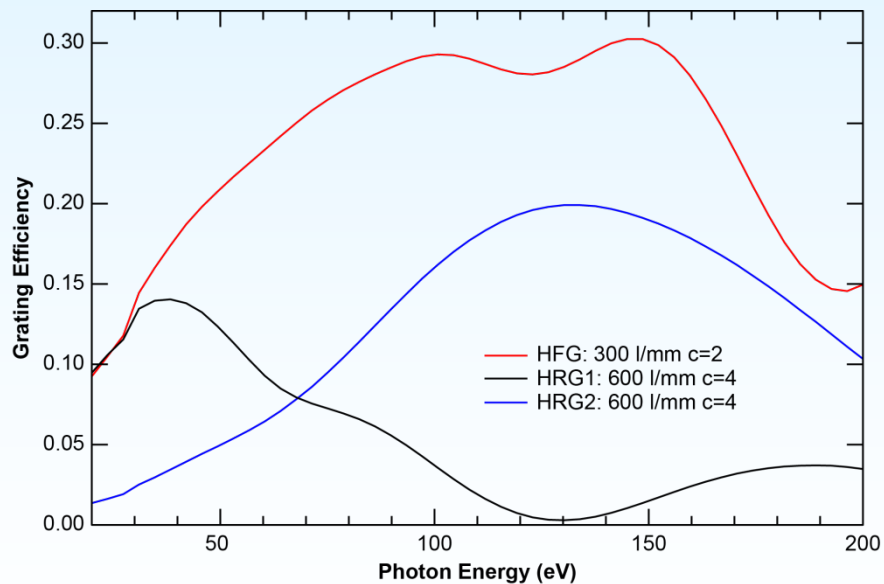
Mirror Coating and Reflectivity

- Best choice: C coated Si
 - High reflectivity
 - Suppress higher orders
- Other options: SiC or Si
- Use APPLE II to correct phase and s/p ratio



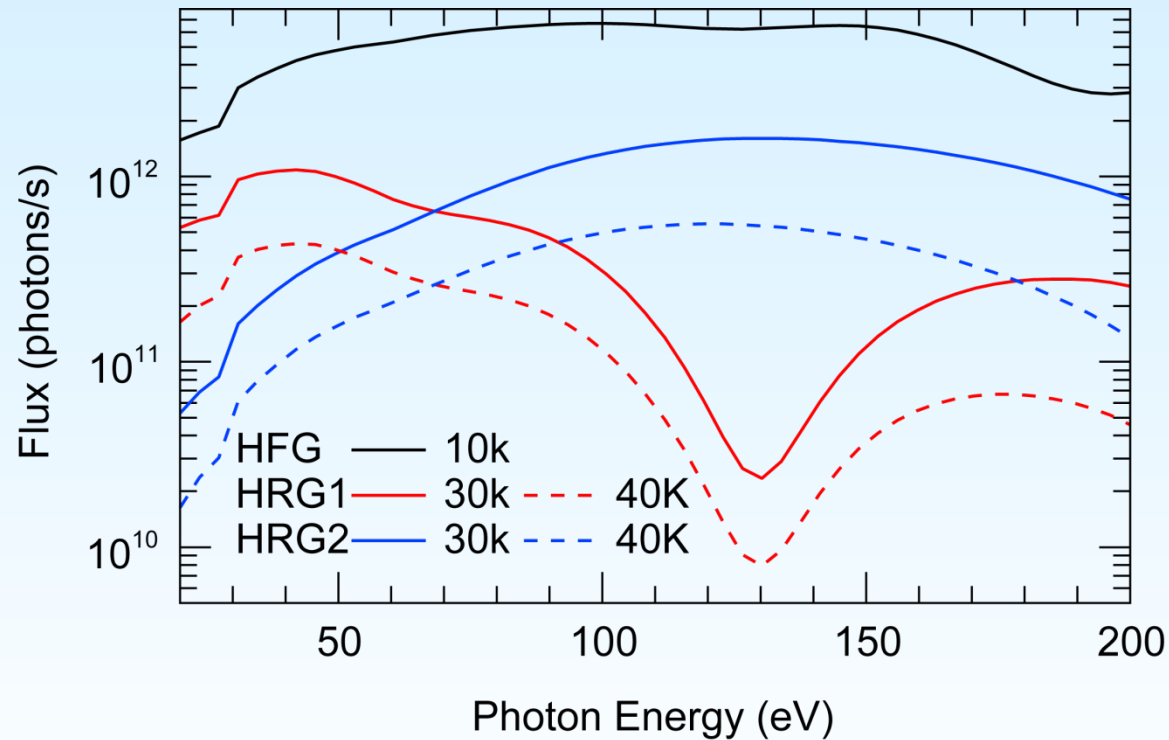
Grating Efficiency and Order Suppression

Grating	c	Line Density k_0	Trapezoidal angle	Groove Depth	Groove Width
HFG	2.0	300 l/mm	28°	40 nm	2.4 μm
HRG1	4.0	600 l/mm	28°	75 nm	1.5 μm
HRG2	4.0	600 l/mm	28°	30 nm	1.5 μm



$$\frac{E1 \times R1}{E1 \times R1 + E2 \times R2 + E3 \times R3 + E4 \times R4}$$

Flux at Sample



ID

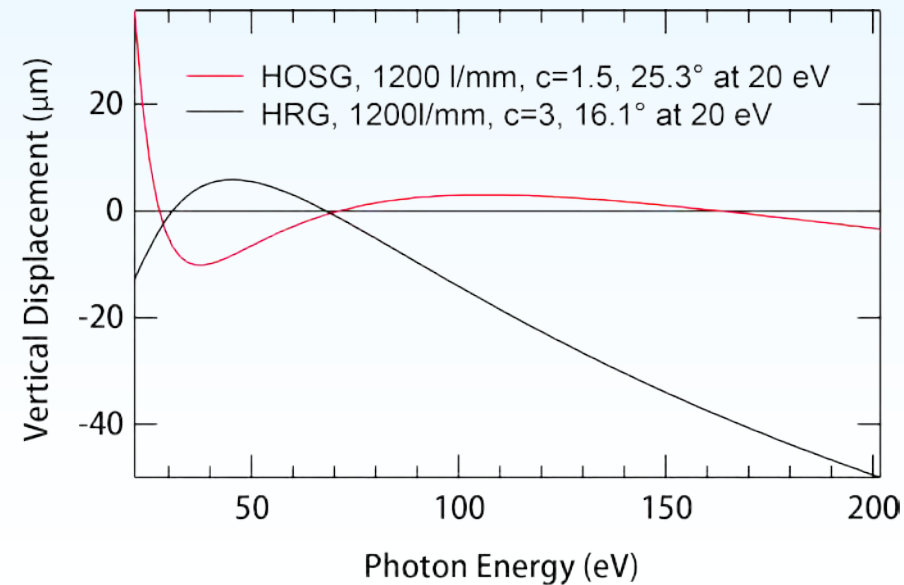
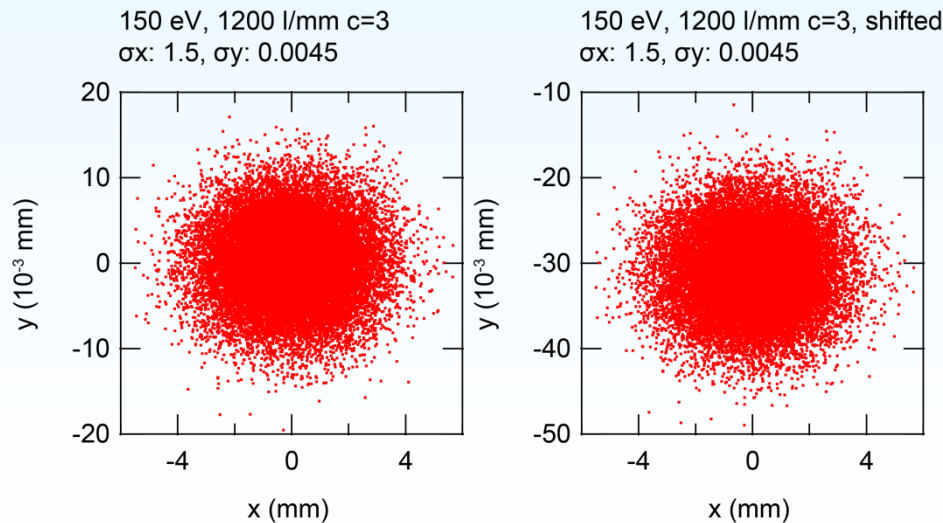
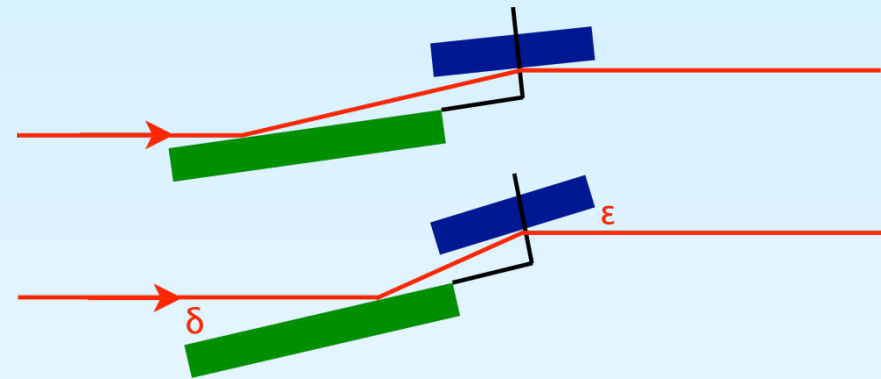
Band pass correction

Grating efficiencies

Reflectivity M0, M1, M2, M3

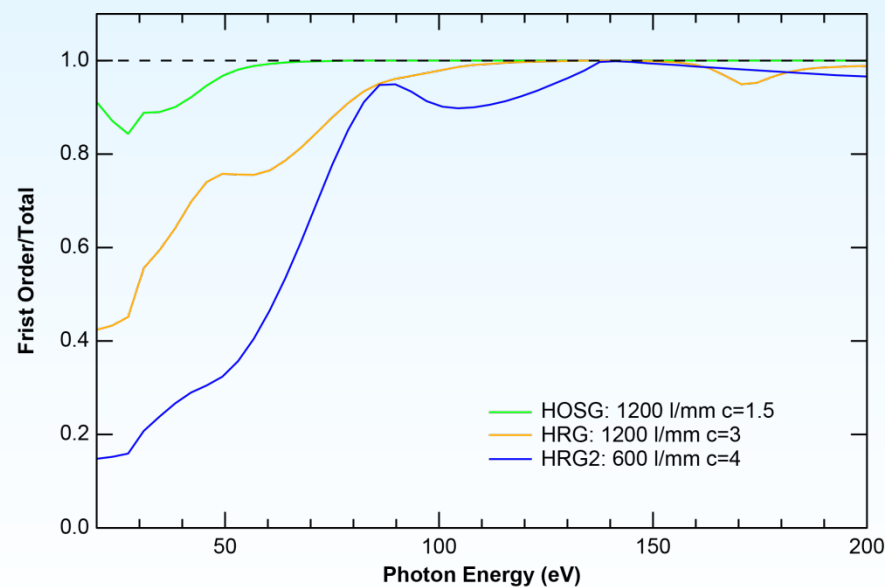
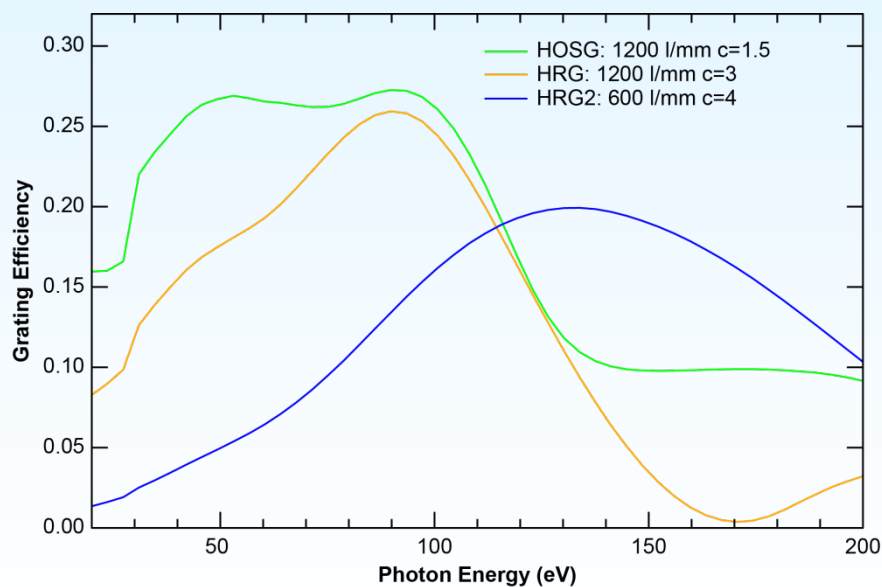
Large Angle Mono

- $\delta < 12^\circ$, $\epsilon < 17^\circ$
- $\delta < 27^\circ$, $\epsilon < 33.5^\circ$
- can use higher line density, small c
- higher order suppression
- beam walking behavior



Large Angle Mono - Grating Efficiency

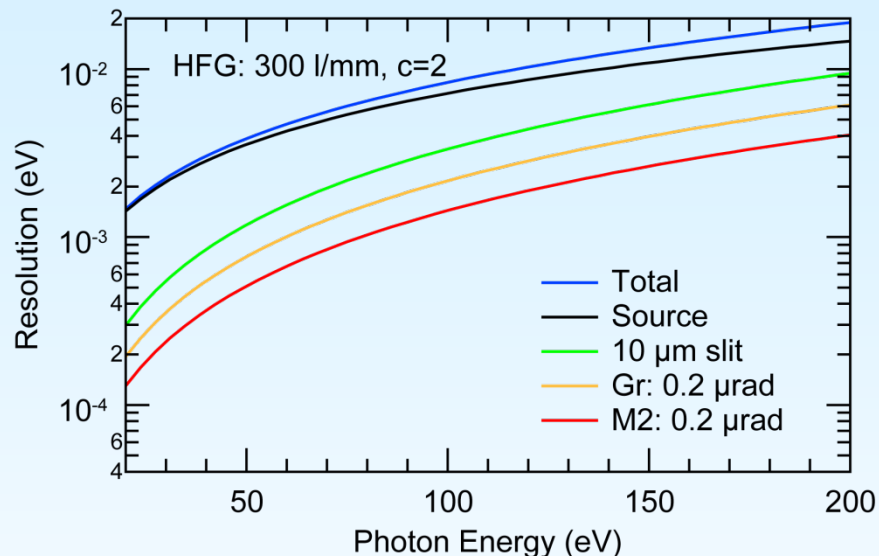
Grating	c	Line Density k_0	Trapezoidal angle	Groove Depth	Groove Width
HOSG	1.5	1200 l/mm	28°	23 nm	0.45 μm
HRG	3.0	1200 l/mm	28°	30 nm	0.65 μm
HRG2	4.0	600 l/mm	28°	30 nm	1.5 μm



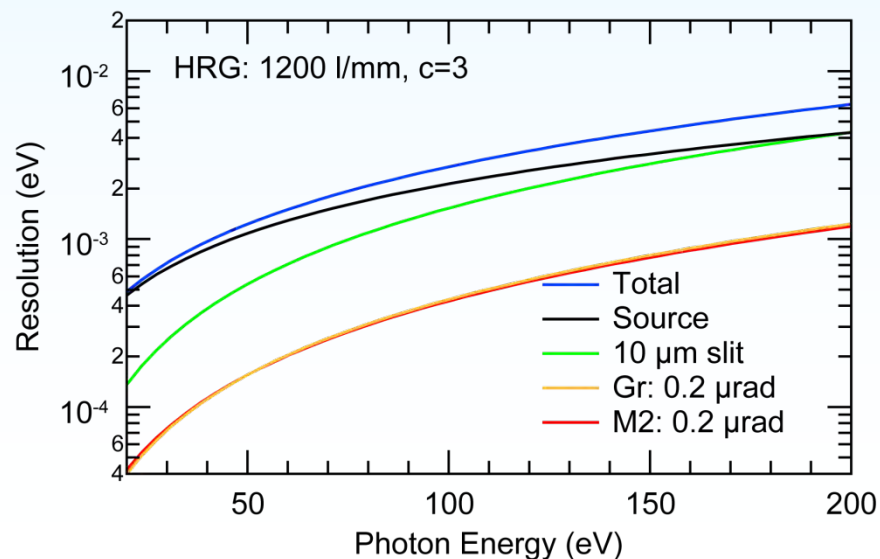
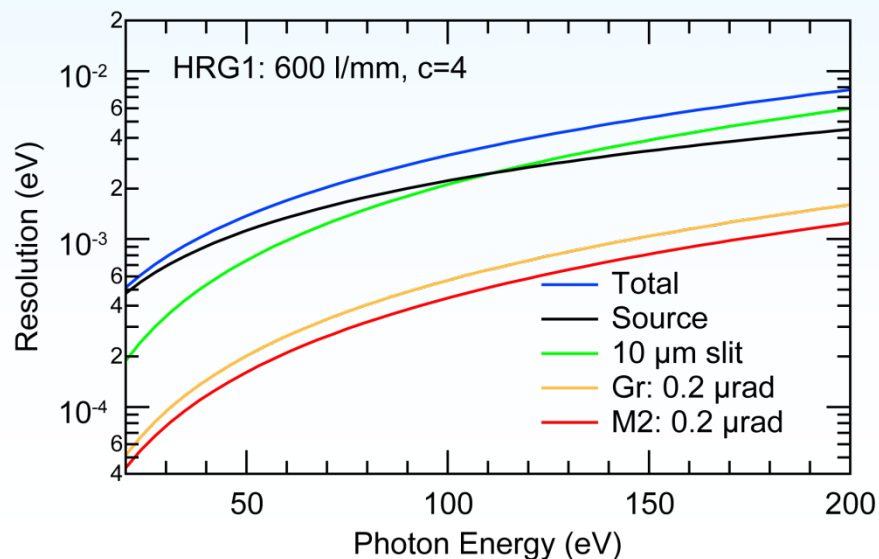
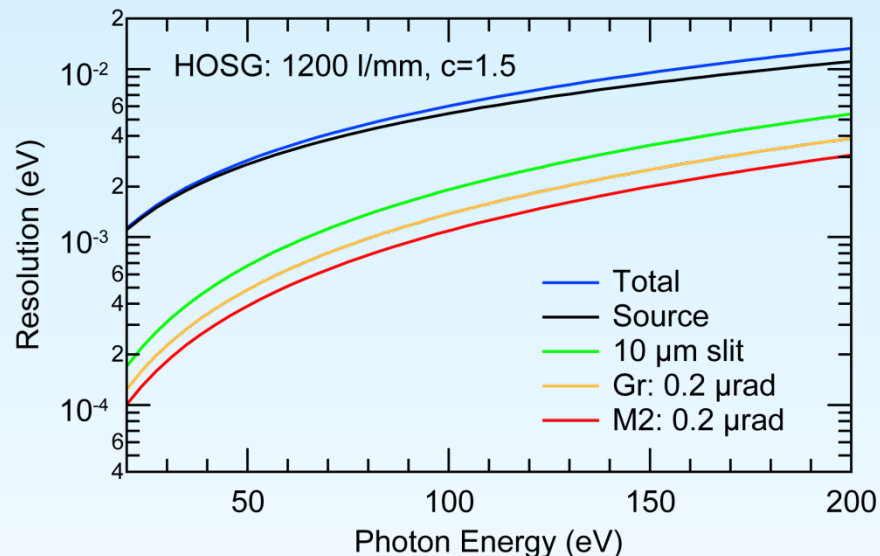
$$\frac{E1 \times R1}{E1 \times R1 + E2 \times R2 + E3 \times R3 + E4 \times R4}$$

Large Angle Mono – Resolution

$\delta < 12^\circ, \epsilon < 17^\circ$

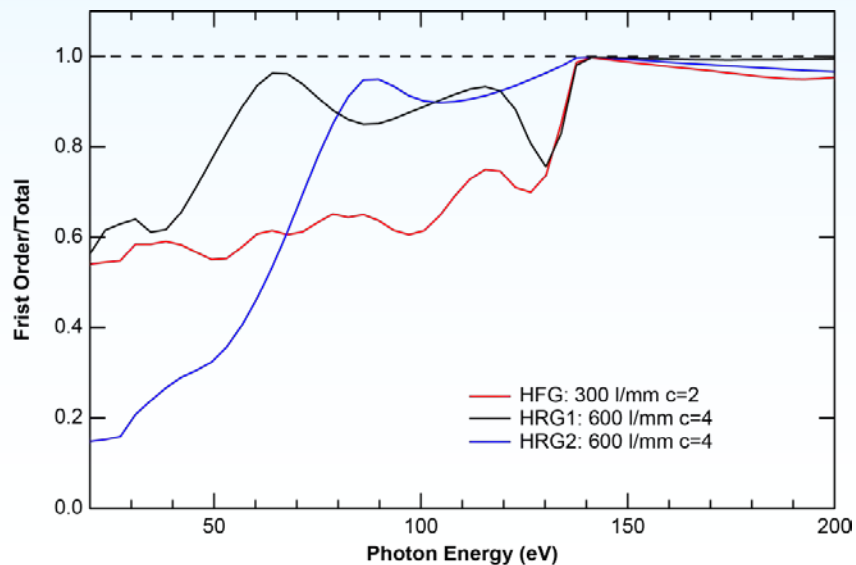
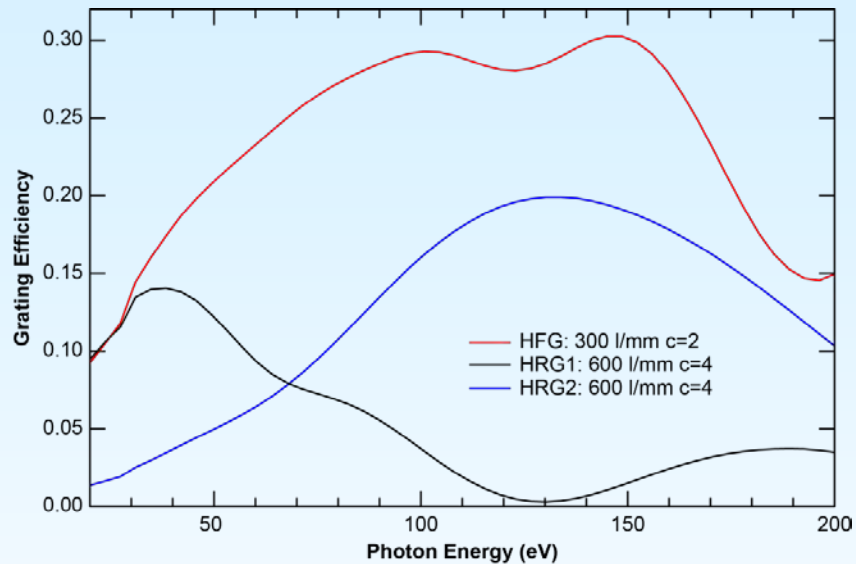


$\delta < 27^\circ, \epsilon < 33.5^\circ$

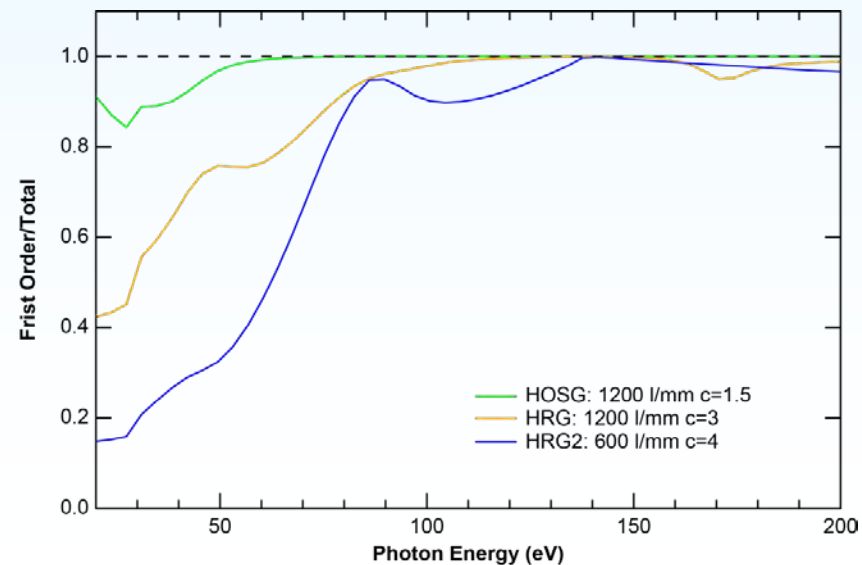
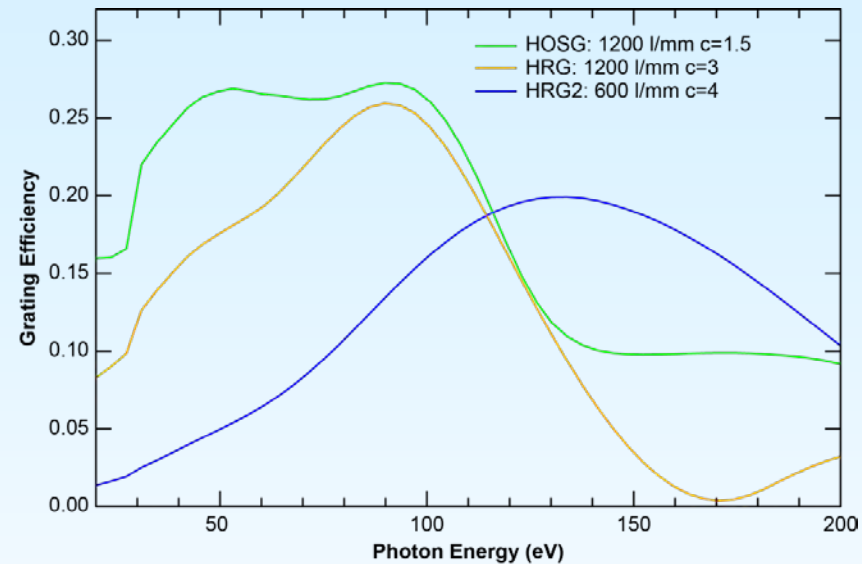


Large Angle Mono – Grating Efficiency

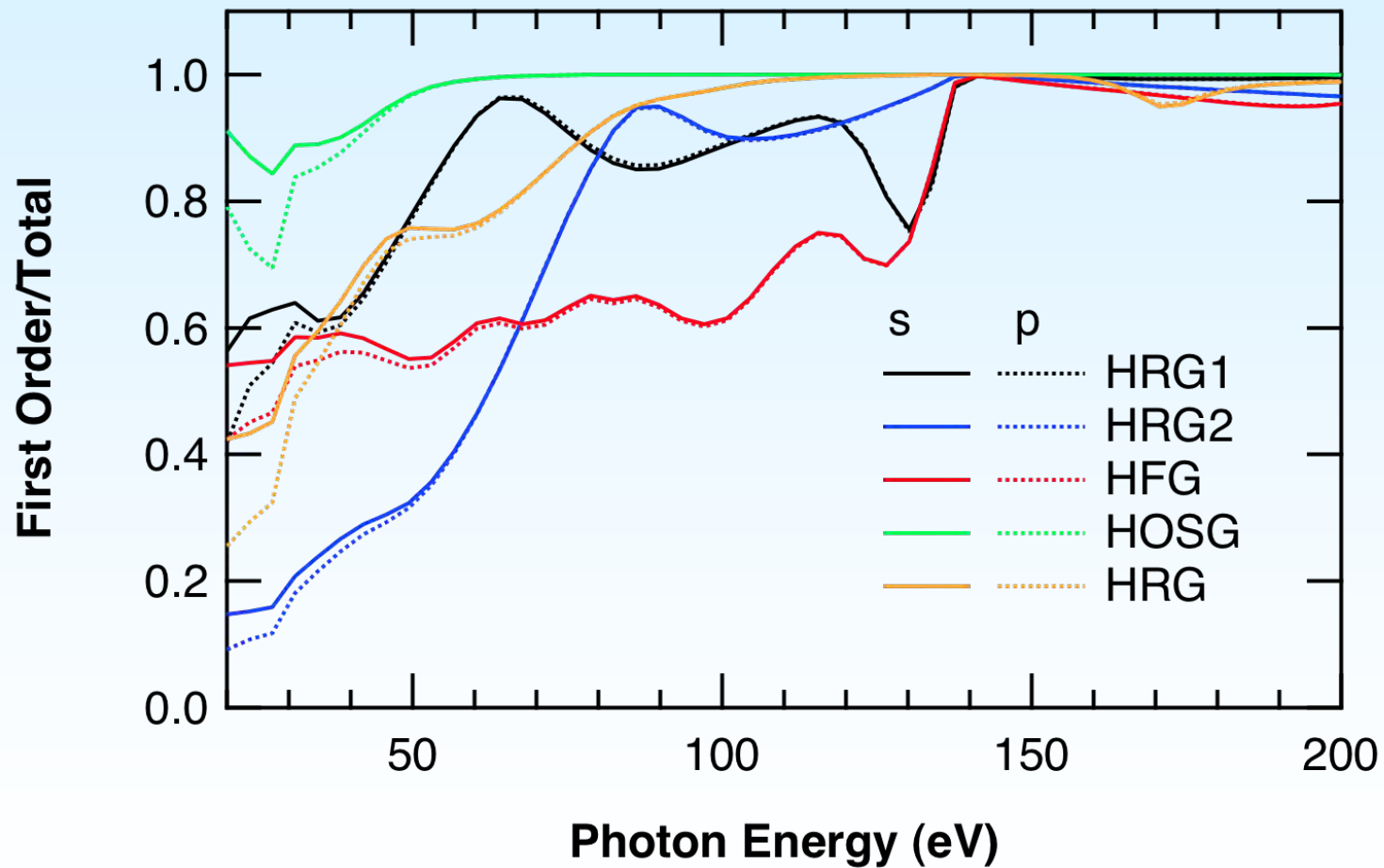
$\delta < 12^\circ, \epsilon < 17^\circ$



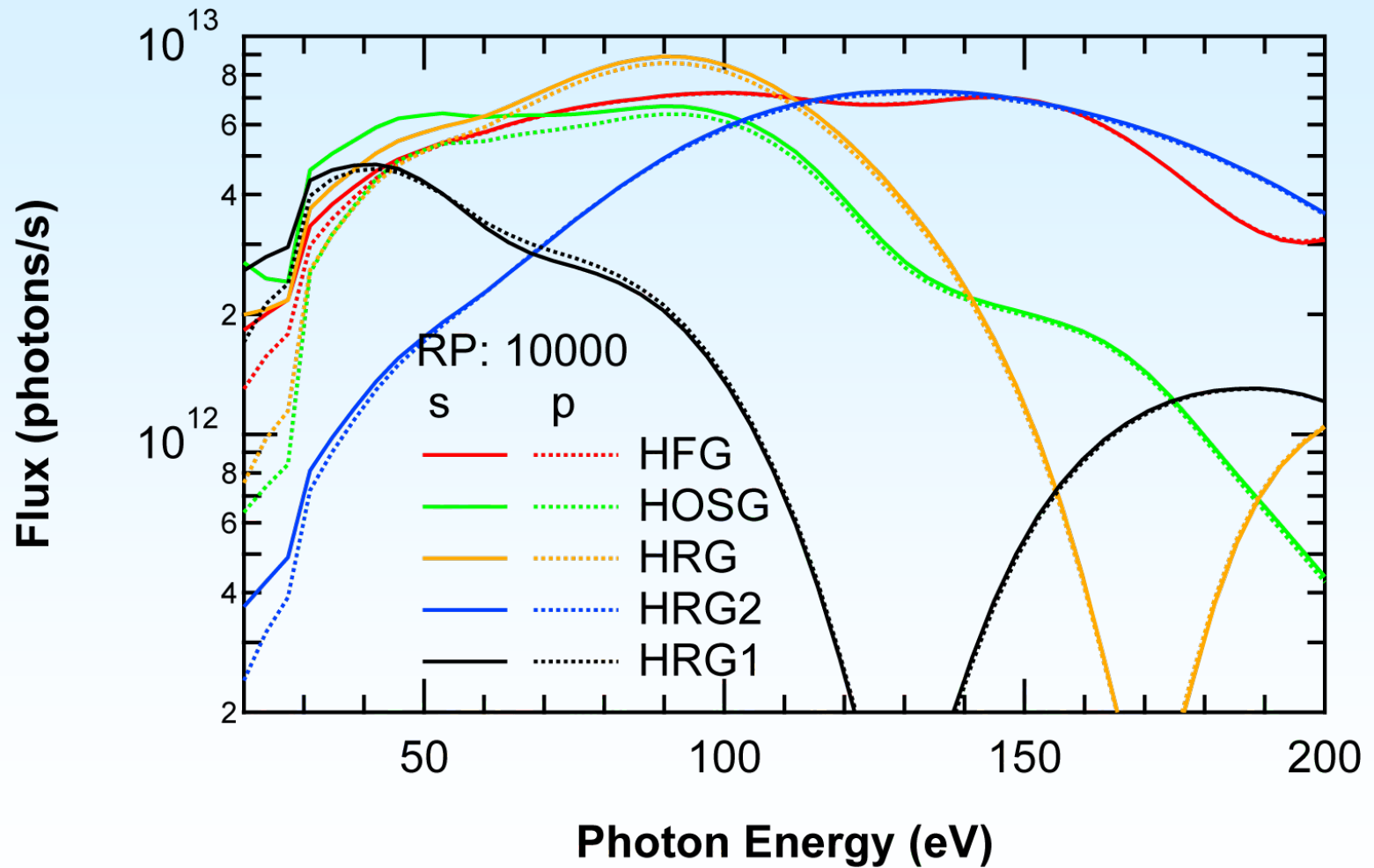
$\delta < 27^\circ, \epsilon < 33.5^\circ$



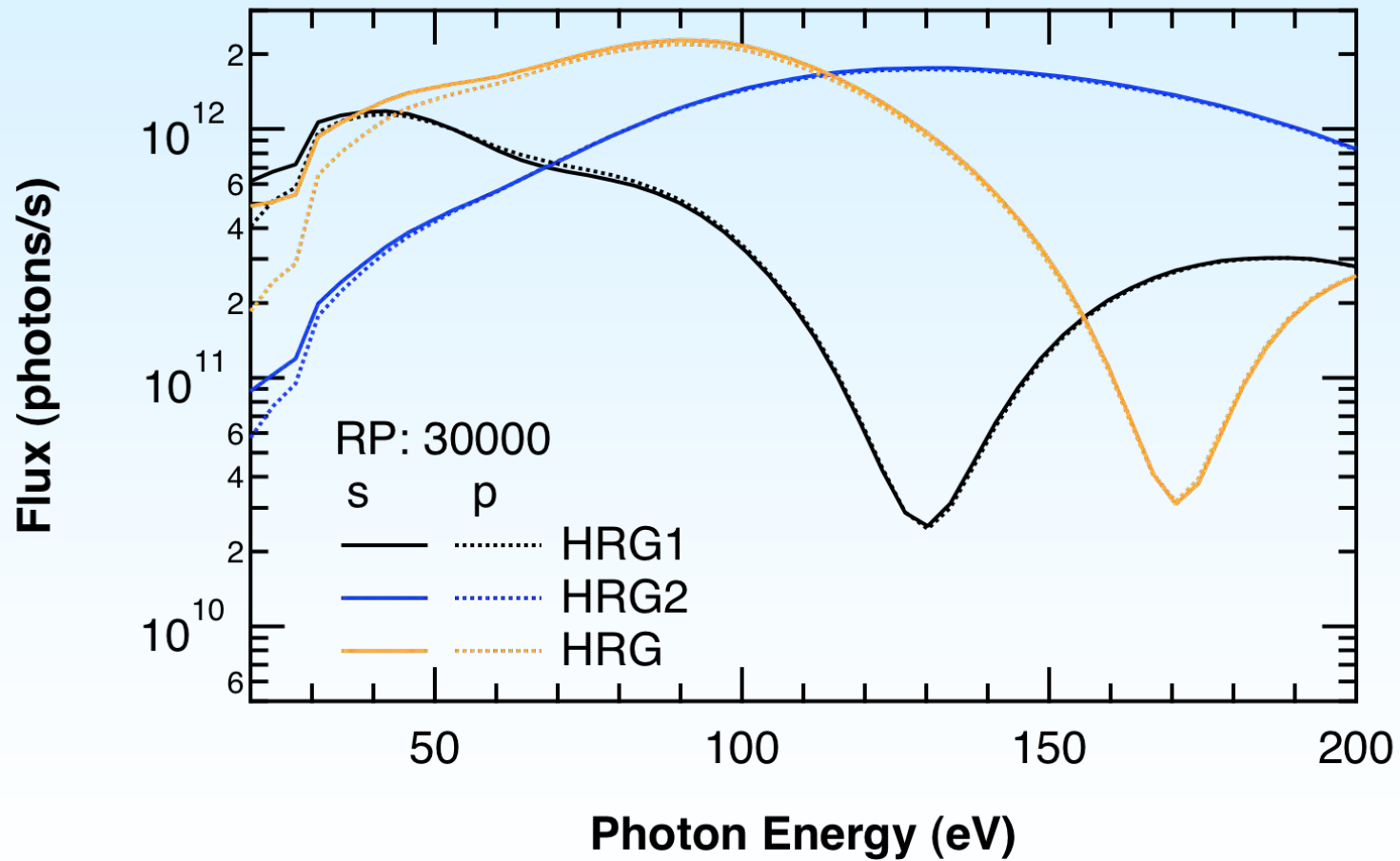
High Order Suppression



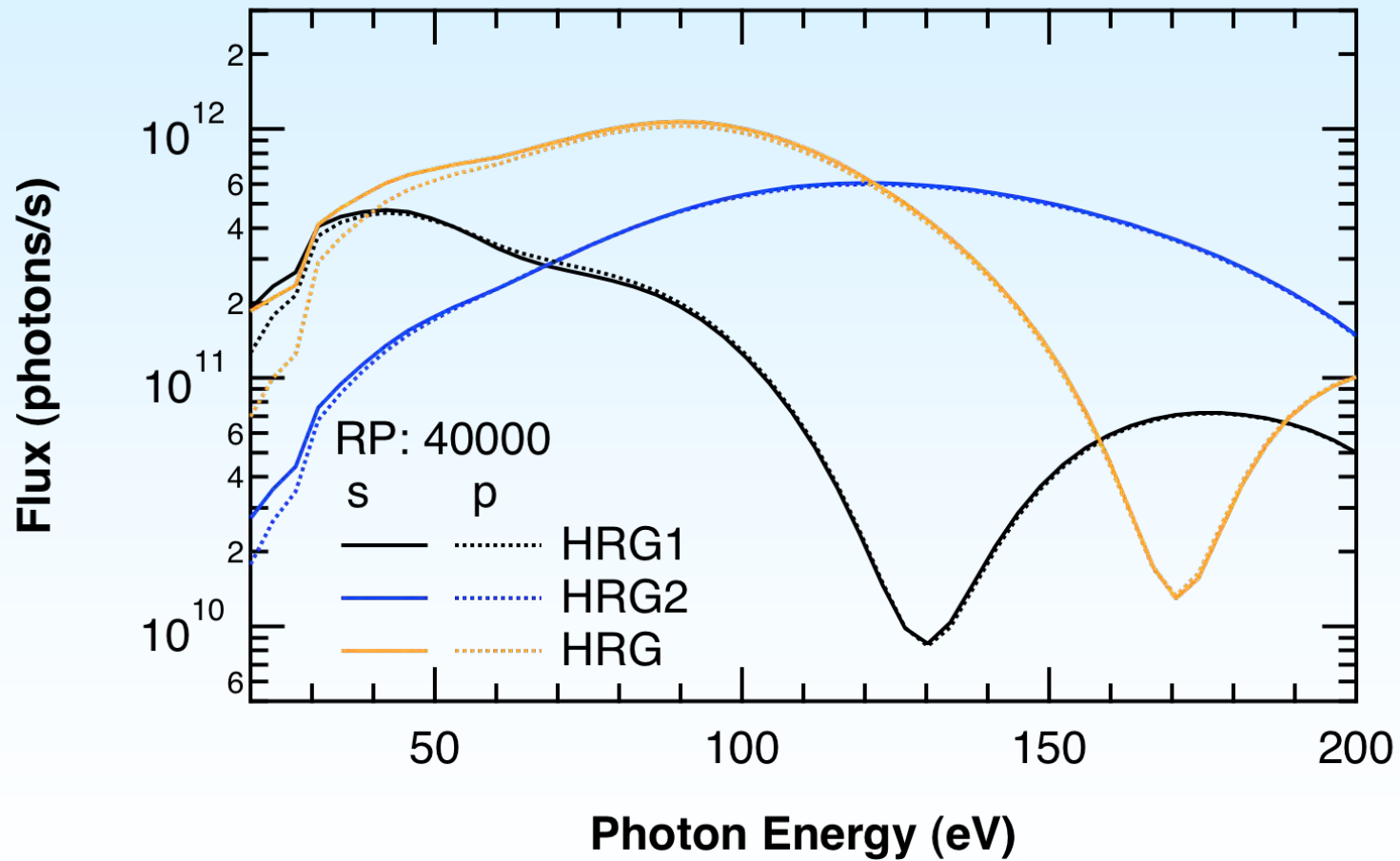
Flux Comparison



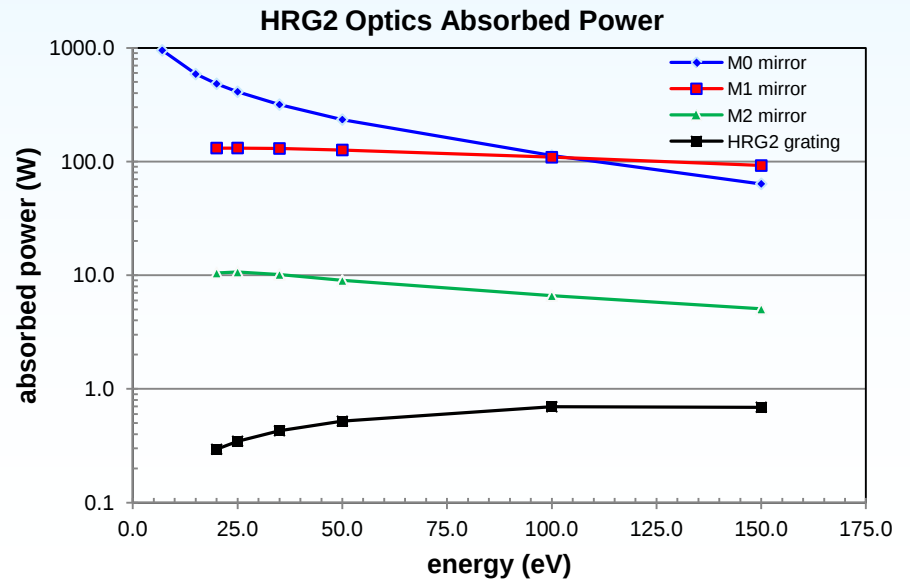
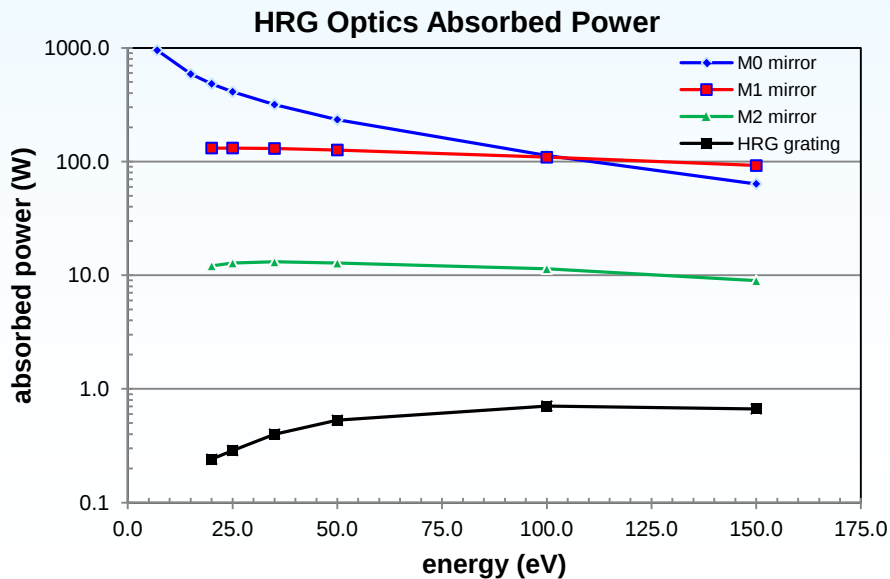
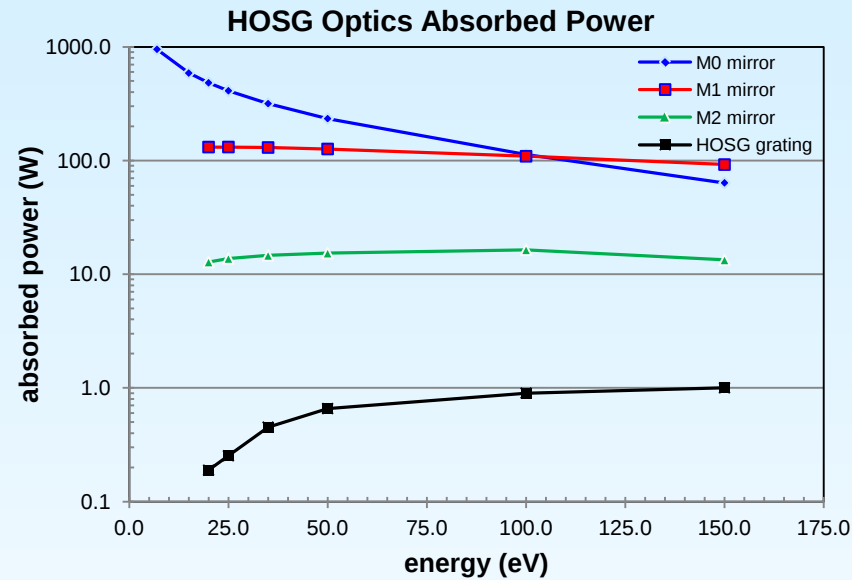
Flux Comparison



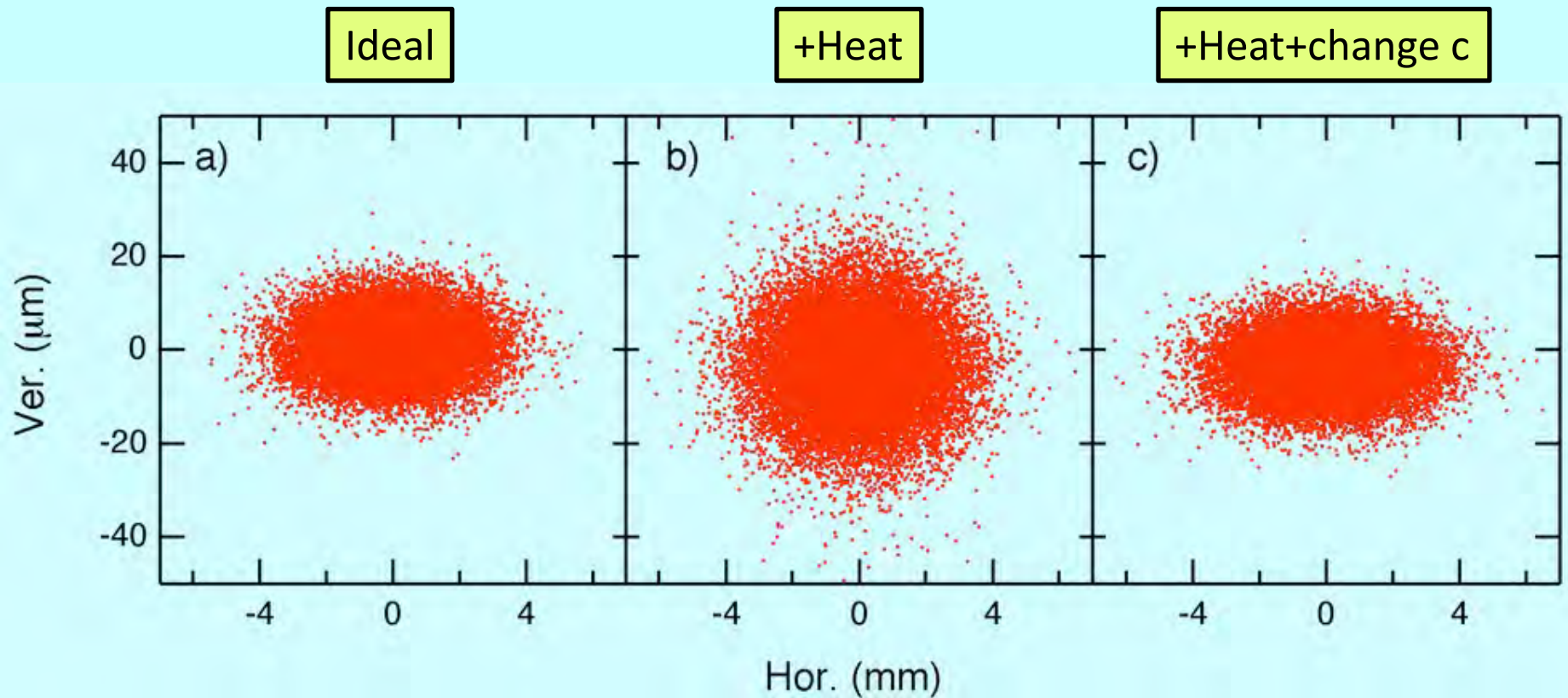
Flux Comparison



Heat Load



Heat Load Compensation



c value
2.183 to 2.201
93% beam